

केन्द्रीय विद्यालय संगठन KENDRIYA VIDYALAYA SANGATHAN मुंबई संभाग MUMBAI REGION



सत्र / SESSION-
2023-2024

कक्षा - बारहवीं
CLASS -XII

मास्टर कार्ड
MASTER CARD

भौतिक विज्ञान
PHYSICS

A sure way to achieve the Goal

केन्द्रीय विद्यालय संगठन, मुंबई संभाग

Kendriya Vidyalaya Sangathan, Regional Office, Mumbai

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समीक्षा, संपादन एवं संकलन
REVIEW, EDITING & COMPILATION



समग्र समीक्षक का नाम NAME OF OVERALL REVIEWER	पद DESIGNATION	केंद्रीय विद्यालय का नाम NAME OF KV
Mr. M.GOPALA REDDY	PGT PHYSICS	KV RHE PUNE

सामग्री CONTENT	संपादक/ संकलक का नाम एवं पद NAME AND DESIGNATION OF EDITOR/ COMPILER	केंद्रीय विद्यालय का नाम NAME OF KV
STUDY MATERIAL & MASTER CARD COVER PAGE DESIGN	Mr. PREM PRAKASH SINGH PGT PHYSICS	KVIIT POWAI, MUMBAI

संकुल वॉर अध्ययन सामग्री निर्माता टीम
CLUSTER WISE TEAM OF PREPARERES



पाठ Ch. No.	पाठ का नाम NAME OF CHAPTER	कोर सदस्य का नाम NAME OF CORE MEMBER	संकुल का नाम NAME OF CLUSTER
1. 2.	ELECTRIC CHARGES AND FIELDS ELECTRIC POTENTIAL AND CAPACITANCE	Mr. VILAS PAWAR PGT PHYSICS K. V. No. 2, AFS Pune	PUNE-2

क्र. सं. S. No.	सदस्य का नाम NAME OF MEMBERS	पद DESIGNATION	केंद्रीय विद्यालय का नाम NAME OF KV
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3.	Mrs. SEEMA BUDHIRAJA	PGT PHYSICS	K.V. 9 BRD, PUNE
4.	Mr. PRAMOD KUMAR	PGT PHYSICS	K.V. BSF, Chakur
5.	Mr. ASHOK KUMAR GUPTA	PGT PHYSICS	K.V. Ganeshkhind, Pune
6.	Dr. SANDIP KAMAT	PGT PHYSICS	K.V. DIAT, Girinagar PUNE
7.	Mr. PRASHANT C. KULKARNI	PGT PHYSICS	K.V. Solapur
8.	Mr. RAJESH KUMAR	PGT PHYSICS	K.V. BEG Pune
9.	Ms. VAISHALI JAISWAL	PGT PHYSICS	K.V. No. 2 AFS Pune

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CLUSTER WISE TEAM OF PREPARERES



पाठ Ch. No.	पाठ का नाम NAME OF CHAPTER	कोर सदस्य का नाम NAME OF CORE MEMBER	संकुल का नाम NAME OF CLUSTER
3.	CURRENT ELECTRICITY	Mr. M.GOPALA REDDY PGT PHYSICS KV RHE PUNE	PUNE-1

क्र. सं S. No.	सदस्य का नाम NAME OF MEMBERS	पद DESIGNATION	केंद्रीय विद्यालय का नाम NAME OF KV
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3.	Mr. SHASHIKANT	PGT PHYSICS	KV ARMY AREA PUNE
4.	Mrs. K. SHANTHI	PGT PHYSICS	KV CME Pune
5.	Ms. NEELAM	PGT PHYSICS	KV SC , Pune
6.	Mrs PARVATHA VARTHINI GIRI	PGT PHYSICS	KV SC , Pune

पाठ Ch. No.	पाठ का नाम NAME OF CHAPTER	कोर सदस्य का नाम NAME OF CORE MEMBER	संकुल का नाम NAME OF CLUSTER
4.	MOVING CHARGES AND MAGNETISM	Dr. RAVINDRA KAMBALE PGT PHYSICS	MUMBAI -1
5.	MAGNETISM AND MATTER	K. V. KOLIWADA	

क्र. सं S. No.	सदस्य का नाम NAME OF MEMBERS	पद DESIGNATION	केंद्रीय विद्यालय का नाम NAME OF KV
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4.	Mr. AKANSHA KHARADIYA	PGT PHYSICS	KV NO 2 COLABA
5.	Mr. M K SINGH	PGT PHYSICS	KV NO 1 COLABA
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8.	Mr. PREM PRAKASH SINGH	PGT PHYSICS	KV IIT POWAI
9.	Mrs. VINEETA SMRITI	PGT PHYSICS	KV KOLIWADA

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CLUSTER WISE TEAM OF PREPARERES



पाठ Ch. No.	पाठ का नाम NAME OF CHAPTER	कोर सदस्य का नाम NAME OF CORE MEMBER	संकुल का नाम NAME OF CLUSTER
6.	ELECTROMAGNETIC INDUCTION	Mr. SANTOSH V. SONTAKKE PGT PHYSICS	NAGPUR
7.	ALTERNATING CURRENT	KV AJNI NAGPUR	

क्र. सं. S. No.	सदस्य का नाम NAME OF MEMBERS	पद DESIGNATION	केंद्रीय विद्यालय का नाम NAME OF KV
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2.	Ms. VIDYA ARORA	PGT PHYSICS	KV VSN NAGPUR
3.	Mr. C.R. RAMTEKE	PGT PHYSICS	KV VSN NAGPUR
4.	Mr. KAMLESH DHARNE	PGT PHYSICS	KV KAMPTEE
5.	Mr. SANJAY CHANDAN	PGT PHYSICS	KV KAMPTEE
6.	Mr. PANKAJ DESHMUKH	PGT PHYSICS	KV WCL NEW MAJRI
7.	Mr. G.G. BHAGAT	PGT PHYSICS	KV YAVATMAL
8.	Mr. B R JAGTAP	PGT PHYSICS	KV OF CHANDA
9.	Mr. KAILASH SHINGADE	PGT PHYSICS	KV OF AMBAJHARI

पाठ Ch. No.	पाठ का नाम NAME OF CHAPTER	कोर सदस्य का नाम NAME OF CORE MEMBER	संकुल का नाम NAME OF CLUSTER
8.	ELECTROMAGNETIC WAVES	Ms. NEHA SHARMA PGT PHYSICS	GOA
11.	DUAL NATURE OF RADIATION AND MATTER	KV INS MANDOLI, GOA	

क्र. सं. S. No.	सदस्य का नाम NAME OF MEMBERS	पद DESIGNATION	केंद्रीय विद्यालय का नाम NAME OF KV
1.	Mr. SHASHI PAUL	PGT PHYSICS	KV PONDA, GOA

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CLUSTER WISE TEAM OF PREPARERES



पाठ Ch. No.	पाठ का नाम NAME OF CHAPTER	कोर सदस्य का नाम NAME OF CORE MEMBER	संकुल का नाम NAME OF CLUSTER
9.	RAY OPTICS AND OPTICAL INSTRUMENTS	Mr. GANESH AHIRRAO PGT PHYSICS	MUMBAI -2
10.	WAVE OPTICS	KV ONGC PANVEL	

क्र. सं. S. No.	सदस्य का नाम NAME OF MEMBERS	पद DESIGNATION	केंद्रीय विद्यालय का नाम NAME OF KV
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5.	Mrs. S. SUGANDI	PGT PHYSICS	KV MANKHURD
6.	Mrs. SWATI CHHABRA	PGT PHYSICS	KV AFS THANE
7.	Mrs. GIRIJA A.	PGT PHYSICS	KV AMBARNATH
8.	Mrs. SAVITA RUHELA	PGT PHYSICS	KV ONGC PANVEL

पाठ Ch. No.	पाठ का नाम NAME OF CHAPTER	कोर सदस्य का नाम NAME OF CORE MEMBER	संकुल का नाम NAME OF CLUSTER
12.	ATOMS	Mr. SUNIL JADHAV PGT PHYSICS	AHMEDNAGAR
13.	NUCLEI	KV Cantt. Aurangabad	

क्र. सं. S. No.	सदस्य का नाम NAME OF MEMBERS	पद DESIGNATION	केंद्रीय विद्यालय का नाम NAME OF KV
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2.	Mr. Avinash Ingle	PGT PHYSICS	KV MIRC Ahmednagar
3.	Mr. PULGAM RAMESH	PGT PHYSICS	KV SCR NANDED

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CLUSTER WISE TEAM OF PREPARERES



पाठ Ch. No.	पाठ का नाम NAME OF CHAPTER	कोर सदस्य का नाम NAME OF CORE MEMBER	संकुल का नाम NAME OF CLUSTER
14.	SEMICONDUCTOR MATERIAL: ELECTRONIC DEVICES	Mr. ASHOK KUMAR PGT PHYSICS KV OF VARANGAON BHUSAWAL	NASHIK

क्र. सं S. No.	सदस्य का नाम NAME OF MEMBERS	पद DESIGNATION	केंद्रीय विद्यालय का नाम NAME OF KV
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2.	Mrs. YOGITA VISHAL THAKUR	PGT PHYSICS	KV ISP NASHIK
3.	Mr. M.B. MALI	PGT PHYSICS	KV AFS OJHAR NASHIK
4.	Mrs. PRATIBHA S.B.	PGT PHYSICS	KV AFS OJHAR NASHIK

इकाई वॉर अध्ययन सामग्री समीक्षकर्ता टीम

UNIT WISE TEAM OF REVIEW TEAM



इकाई सं. Unit No.	इकाई का नाम Name of the Unit	अध्ययन सामग्री निर्माता संकुल Name of the Cluster material prepared	अध्ययन सामग्री समीक्षकर्ता संकुल Name of the cluster reviewing the material	संकुल के प्रभारी का नाम Name of the core in charge
1	Electrostatics	Pune – 2	Nashik Mr Ashok Kumar	Mr. Vilas Pawar (KV No.2 AFS)
2	Current Electricity	Pune – 1	Goa Ms Neha Sharma	Mr. M G Reddy (KV RHE)
3	Magnetic Effects of Current and Magnetism	Mumbai - 1	Pune – 2 Mr. Vilas Pawar	Mr. Ravindra Kamble (KVKoliwada)
4	Electromagnetic Induction and Alternating Currents	Nagpur	Mumbai –2 Mr. Ganesh Ahirrao	Mr. Santosh V Sontakke (KV Ajni Nagpur)
5	Electromagnetic waves	Goa	Ahmednagar Mr. Sunil Jadhav	Ms. Neha Sharma (KV INS Mandovi)
6	Optics	Mumbai - 2	Nagpur Mr. Santosh V Sontakke	Mr. Ganesh Ahirrao (KV ONGC Panvel)
7	Dual Nature of Radiation and Matter	Goa	Ahmednagar Mr. Sunil Jadhav	Ms. Neha Sharma (KV INS Mandovi)
8	Atoms and Nuclei	Ahmednagar	Mumbai – 1 Mr. Ravindra Kamble	Mr. Sunil Jadhav (KV CANT Aurangabad)
9	Electronic Devices	Nashik	Pune – 1 M.G Reddy	Mr. Ashok Kumar (KV OF Varangaon)

विषय सूची INDEX

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CLASS XII (2023-24) PHYSICS (THEORY)

Time: 3 hrs.

Max Marks: 70

		No. of Periods	Marks
Unit-I	Electrostatics	26	16
	Chapter-1: Electric Charges and Fields		
	Chapter-2: Electrostatic Potential and Capacitance		
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	Chapter-3: Current Electricity		
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	Chapter-4: Moving Charges and Magnetism		
	Chapter-5: Magnetism and Matter		
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	Chapter-6: Electromagnetic Induction		
	Chapter-7: Alternating Current		
Unit-V	Electromagnetic Waves	04	18
	Chapter-8: Electromagnetic Waves		
Unit-VI	Optics	30	
	Chapter-9: Ray Optics and Optical Instruments		
	Chapter-10: Wave Optics		
Unit-VII	Dual Nature of Radiation and Matter	8	12
	Chapter-11: Dual Nature of Radiation and Matter		
Unit-VIII	Atoms and Nuclei	15	
	Chapter-12: Atoms		
	Chapter-13: Nuclei		
Unit-IX	Electronic Devices	10	7
	Chapter-14: Semiconductor Electronics: Materials, Devices and Simple Circuits		
	Total	160	70

COURSE STRUCTURE 2023-2024

Unit I: Electrostatics

26 Periods

Chapter–1: Electric Charges and Fields

Electric charges, Conservation of charge, Coulomb's law-force between two- point charges, forces between multiple charges; superposition principle and continuous charge distribution. Electric field, electric field due to a point charge, electric field lines, electric dipole, electric field due to a dipole, torque on a dipole in uniform electric field. Electric flux, statement of Gauss's theorem and its applications to find field due to infinitely long straight wire, uniformly charged infinite plane sheet and uniformly charged thin spherical shell (field inside and outside).

Chapter–2: Electrostatic Potential and Capacitance

Electric potential, potential difference, electric potential due to a point charge, a dipole and system of charges; equipotential surfaces, electrical potential energy of a system of two-point charges and of electric dipole in an electrostatic field. Conductors and insulators, free charges and bound charges inside a conductor. Dielectrics and electric polarization, capacitors and capacitance, combination of capacitors in series and in parallel, capacitance of a parallel plate capacitor with and without dielectric medium between the plates, energy stored in a capacitor (no derivation, formulae only).

Unit II: Current Electricity

18 Periods

Chapter–3: Current Electricity

Electric current, flow of electric charges in a metallic conductor, drift velocity, mobility and their relation with electric current; Ohm's law, V-I characteristics (linear and non-linear), electrical energy and power, electrical resistivity and conductivity, temperature dependence of resistance, Internal resistance of a cell, potential difference and emf of a cell, combination of cells in series and in parallel, Kirchhoff's rules, Wheatstone bridge.

Unit III: Magnetic Effects of Current and Magnetism

25 Periods

Chapter–4: Moving Charges and Magnetism

Concept of magnetic field, Oersted's experiment. Biot - Savart law and its application to current carrying circular loop. Ampere's law and its applications to infinitely long straight wire. Straight solenoid (only qualitative treatment), force on a moving charge in uniform magnetic and electric fields. Force on a current-carrying conductor in a uniform magnetic field, force between two parallel current-carrying conductors-definition of ampere, torque experienced by a current loop in uniform magnetic field; Current loop as a magnetic dipole and its magnetic dipole moment, moving coil galvanometer- its current sensitivity and conversion to ammeter and voltmeter.

Chapter–5: Magnetism and Matter

Bar magnet, bar magnet as an equivalent solenoid (qualitative treatment only), magnetic field intensity due to a magnetic dipole (bar magnet) along its axis and perpendicular to its axis (qualitative treatment only), torque on a magnetic dipole (bar magnet) in a uniform magnetic field (qualitative treatment only), magnetic field lines. Magnetic properties of materials- Para-, dia- and ferro - magnetic substances with examples, Magnetization of materials, effect of temperature on magnetic properties.

Unit IV: Electromagnetic Induction and Alternating Currents

24 Periods

Chapter–6: Electromagnetic Induction

Electromagnetic induction; Faraday's laws, induced EMF and current; Lenz's Law, Self and mutual induction.

Chapter–7: Alternating Current

Alternating currents, peak and RMS value of alternating current/voltage; reactance and impedance; LCR series circuit (phasors only), resonance, power in AC circuits, power factor, wattless current. AC generator, Transformer.

Unit V: Electromagnetic waves

04 Periods

Chapter–8: Electromagnetic Waves

Basic idea of displacement current, Electromagnetic waves, their characteristics, their transverse nature (qualitative idea only). Electromagnetic spectrum (radio waves, microwaves, infrared, visible, ultraviolet, X-rays, gamma rays) including elementary facts about their uses.

Unit VI: Optics

30 Periods

Chapter–9: Ray Optics and Optical Instruments

Ray Optics: Reflection of light, spherical mirrors, mirror formula, refraction of light, total internal reflection and optical fibers, refraction at spherical surfaces, lenses, thin lens formula, lens maker's formula, magnification, power of a lens, combination of thin lenses in contact, refraction of light through a prism. Optical instruments: Microscopes and astronomical telescopes (reflecting and refracting) and their magnifying powers.

Chapter–10: Wave Optics

Wave optics: Wave front and Huygen's principle, reflection and refraction of plane wave at a plane surface using wave fronts. Proof of laws of reflection and refraction using Huygen's principle. Interference, Young's double slit experiment and expression for fringe width (No derivation final expression only), coherent sources and sustained interference of light, diffraction due to a single slit, width of central maxima (qualitative treatment only).

Unit VII: Dual Nature of Radiation and Matter

08 Periods

Chapter–11: Dual Nature of Radiation and Matter

Dual nature of radiation, Photoelectric effect, Hertz and Lenard's observations; Einstein's photoelectric equation-particle nature of light. Experimental study of photoelectric effect Matter waves-wave nature of particles, de-Broglie relation.

Unit VIII: Atoms and Nuclei

15 Periods

Chapter–12: Atoms

Alpha-particle scattering experiment; Rutherford's model of atom; Bohr model of hydrogen atom, Expression for radius of nth possible orbit, velocity and energy of electron in nth orbit, hydrogen line spectra (qualitative treatment only).

Chapter–13: Nuclei

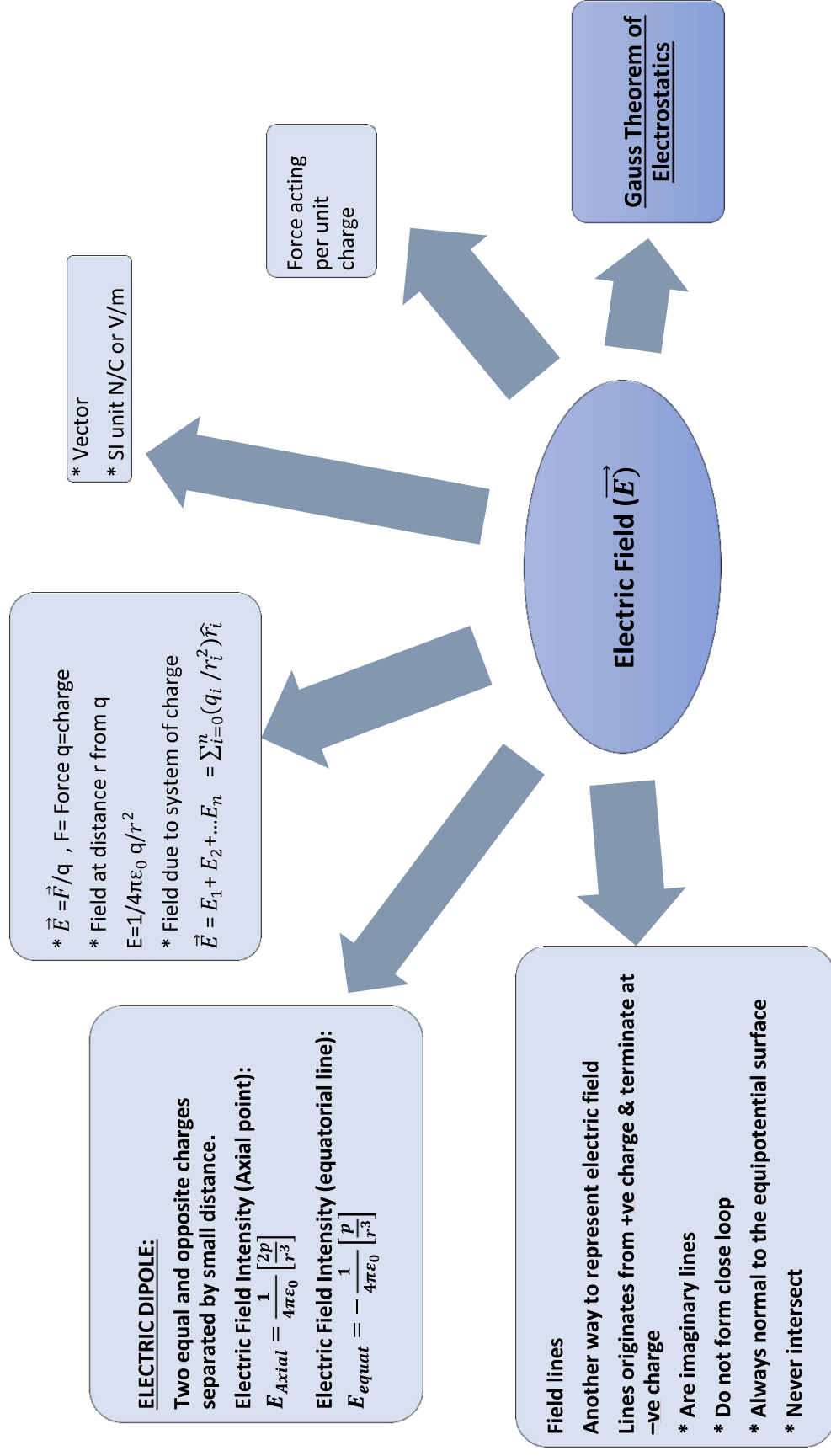
Composition and size of nucleus, nuclear force Mass-energy relation, mass defect; binding energy per nucleon and its variation with mass number; nuclear fission, nuclear fusion.

Unit IX: Electronic Devices 10 Periods

Chapter–14: Semiconductor Electronics:

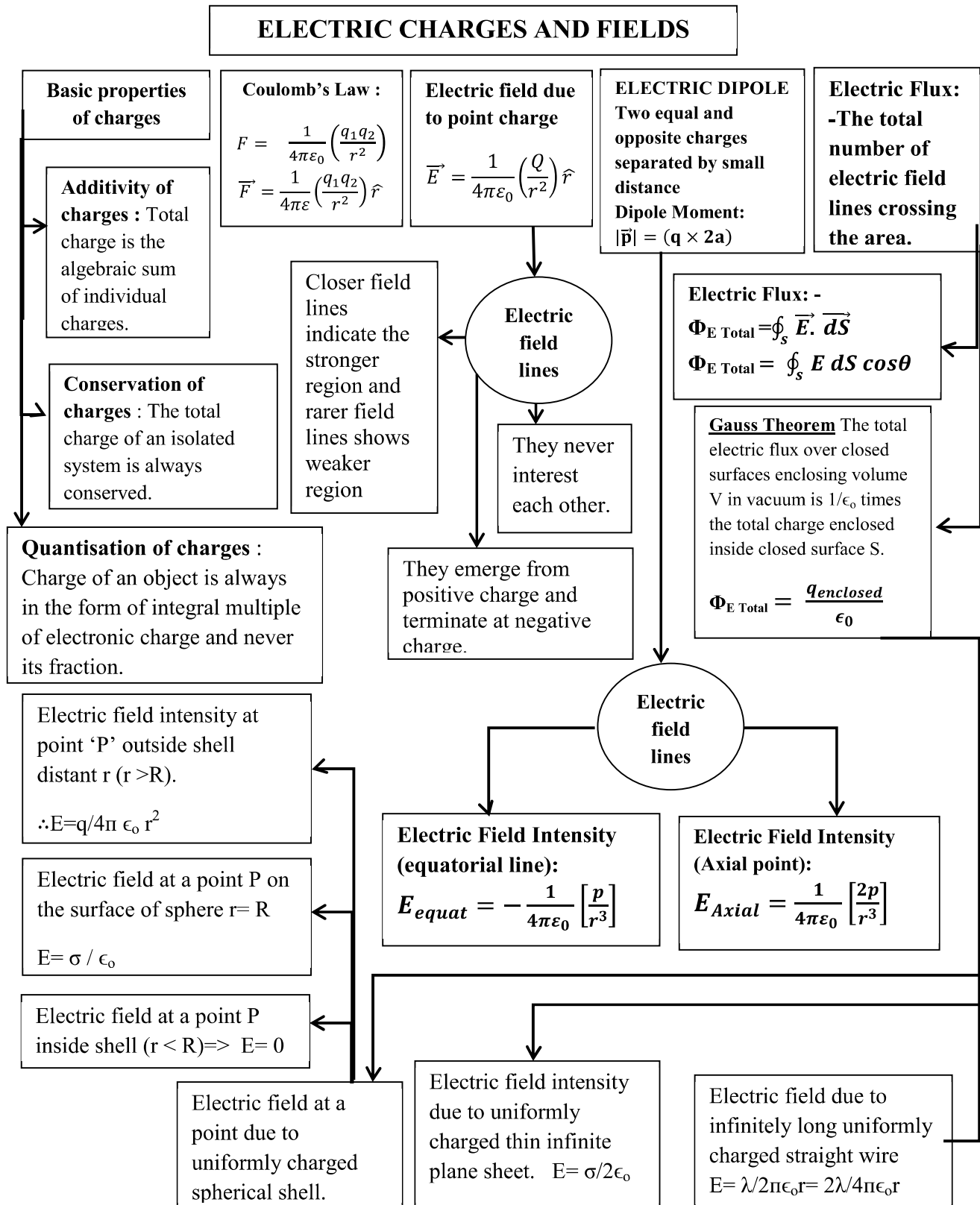
Materials, Devices and Simple Circuits Energy bands in conductors, semiconductors and insulators (qualitative ideas only) Intrinsic and extrinsic semiconductors- p and n type, p-n junction Semiconductor diode - I-V characteristics in forward and reverse bias, application of junction diode -diode as a rectifier

MIND MAP- Chapter -1 ELECTRIC CHARGES AND FIELDS



Chapter -1 ELECTRIC CHARGES AND FIELDS

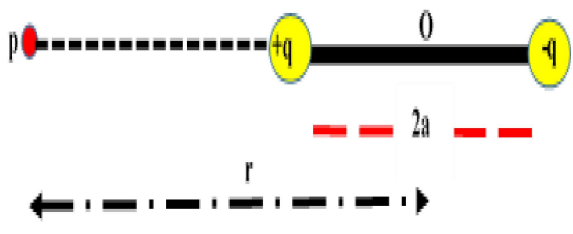
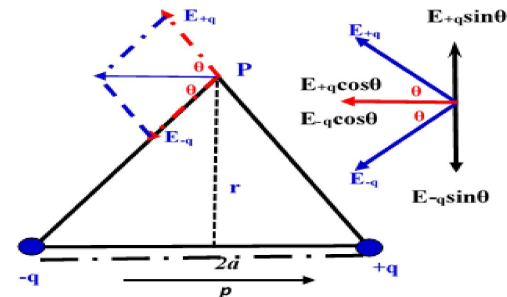
MasterCard



ELECTRIC DIPOLE

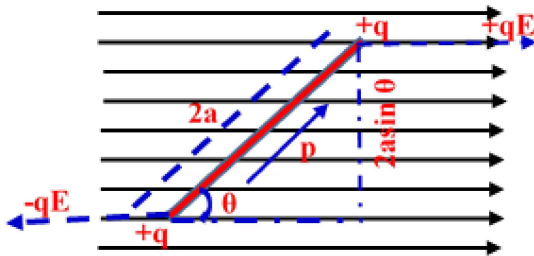
- *Electric dipole is a pair of equal and opposite charges separated by a very small distance.*
- Electric dipole moment is a vector quantity used to measure the strength of an electric dipole. $\vec{p} = (q \times 2a)$

ELECTRIC FIELD INTENSITY DUE TO AN ELECTRIC DIPOLE

Axial line	Equatorial line
	
$E_{Axial} = \frac{1}{4\pi\epsilon_0} \left[\frac{2p}{r^3} \right]$	$E_{equat} = -\frac{1}{4\pi\epsilon_0} \left[\frac{p}{r^3} \right]$

ELECTRIC DIPOLE IN A UNIFORM ELECTRIC FIELD

TORQUE



$$\tau = \vec{p} \times \vec{E}$$

Case i: If $\theta = 0^\circ$, then $\tau = 0$.

Case ii: If $\theta = 90^\circ$, then $\tau = pE$ (maximum value).

Case iii: If $\theta = 180^\circ$, then $\tau = 0$.

POTENTIAL ENERGY

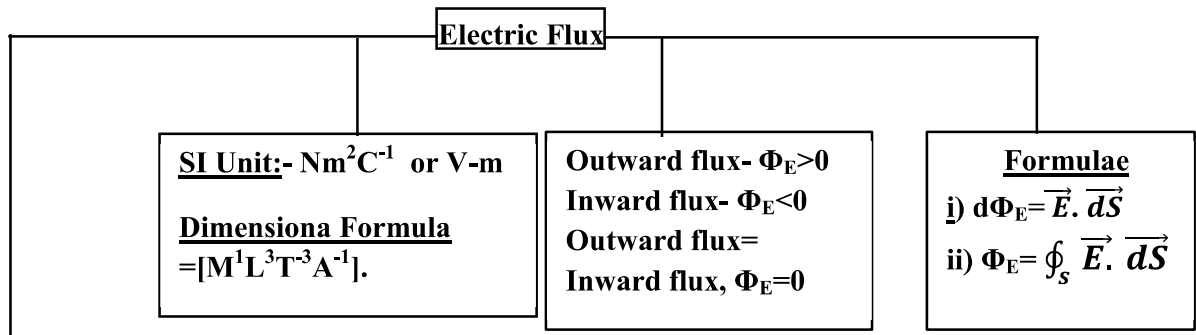
If $\theta = 180^\circ$, then $U = pE$
(Unstable Equilibrium)

Potential Energy $U = -pE \cos \theta$

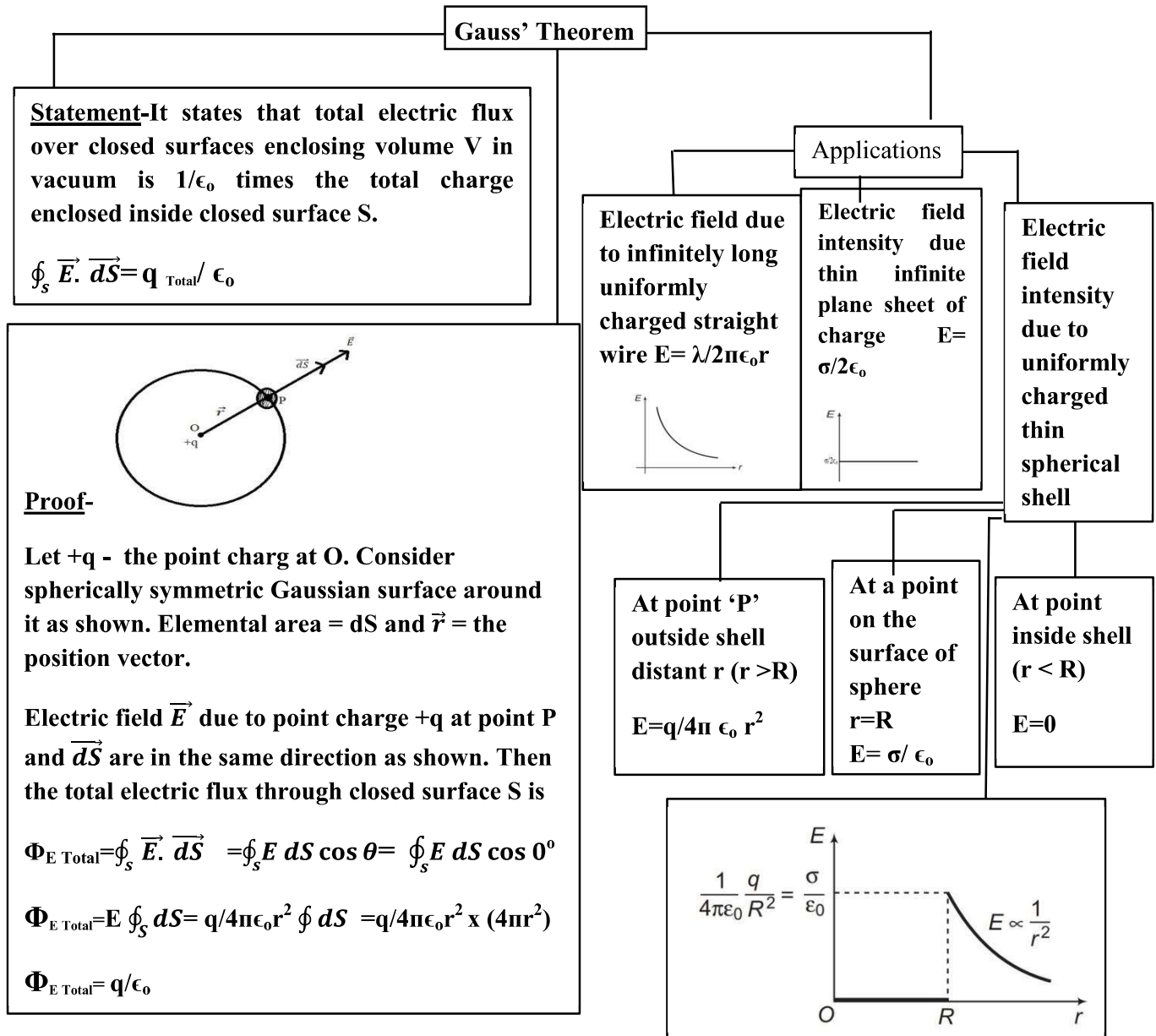
If $\theta = 90^\circ$, then $U = 0$

If $\theta = 0^\circ$, then $U = -pE$
(Stable Equilibrium)

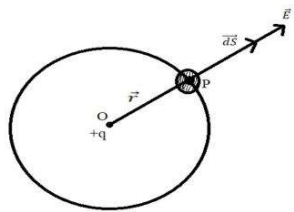
Electric Flux and Gauss Theorem



Definition- Electric flux over an area represents/measures total number of electric field lines crossing the area when it is held normal to the field direction.



Proof-



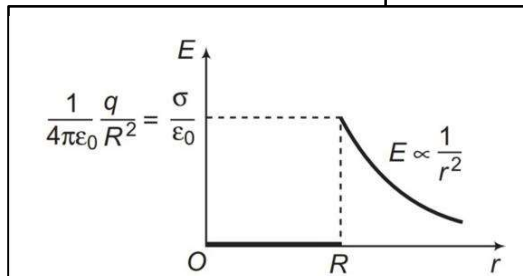
Let $+q$ - the point charge at O. Consider spherically symmetric Gaussian surface around it as shown. Elemental area = dS and $\vec{r}$ = the position vector.

Electric field $\vec{E}$ due to point charge $+q$ at point P and $\vec{dS}$ are in the same direction as shown. Then the total electric flux through closed surface S is

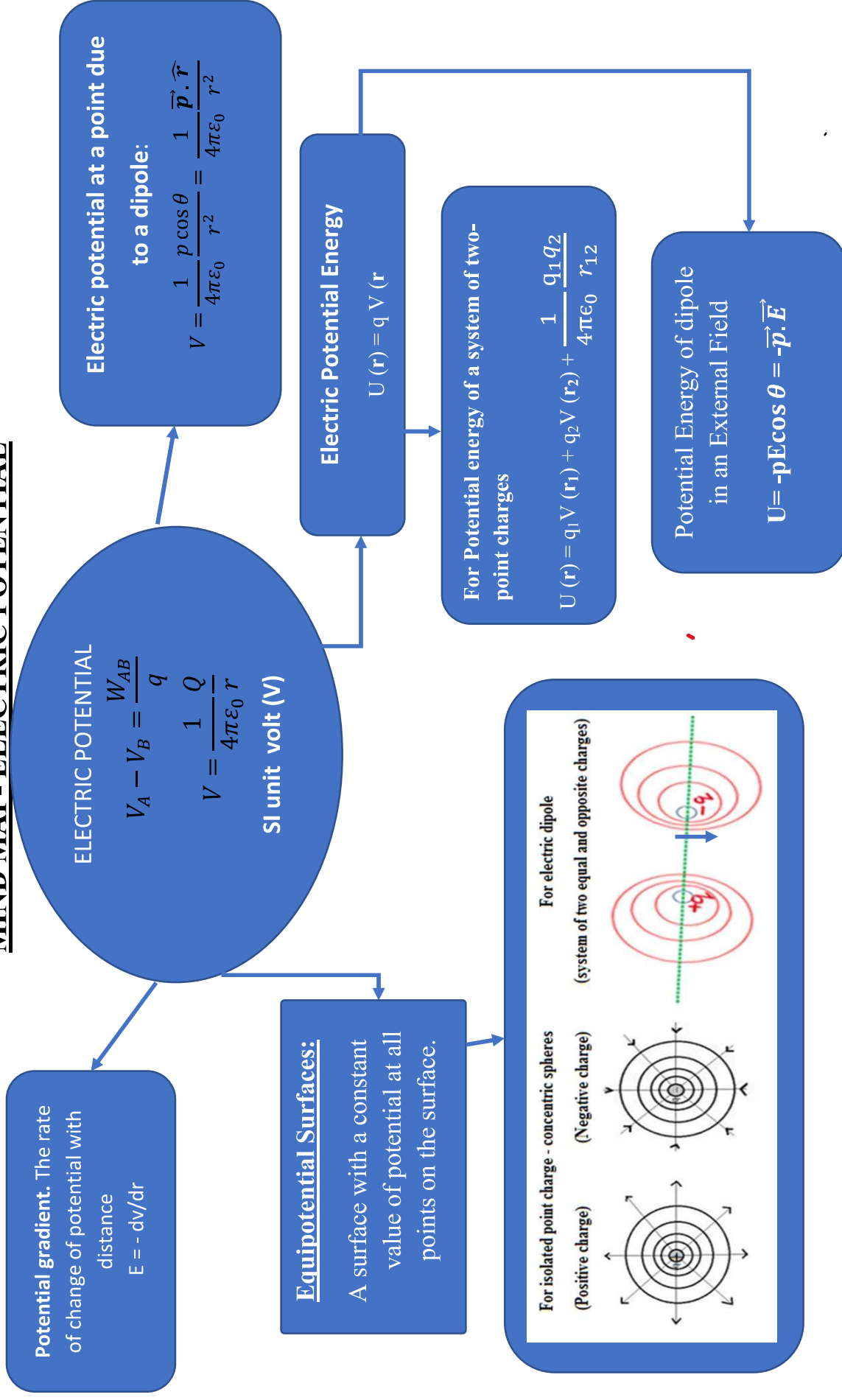
$\Phi_{E \text{ Total}} = \oint_S \vec{E} \cdot \vec{dS} = \oint_S E dS \cos \theta = \oint_S E dS \cos 0^\circ$

$\Phi_{E \text{ Total}} = E \oint_S dS = q / 4\pi\epsilon_0 r^2 \oint_S dS = q / 4\pi\epsilon_0 r^2 \times (4\pi r^2)$

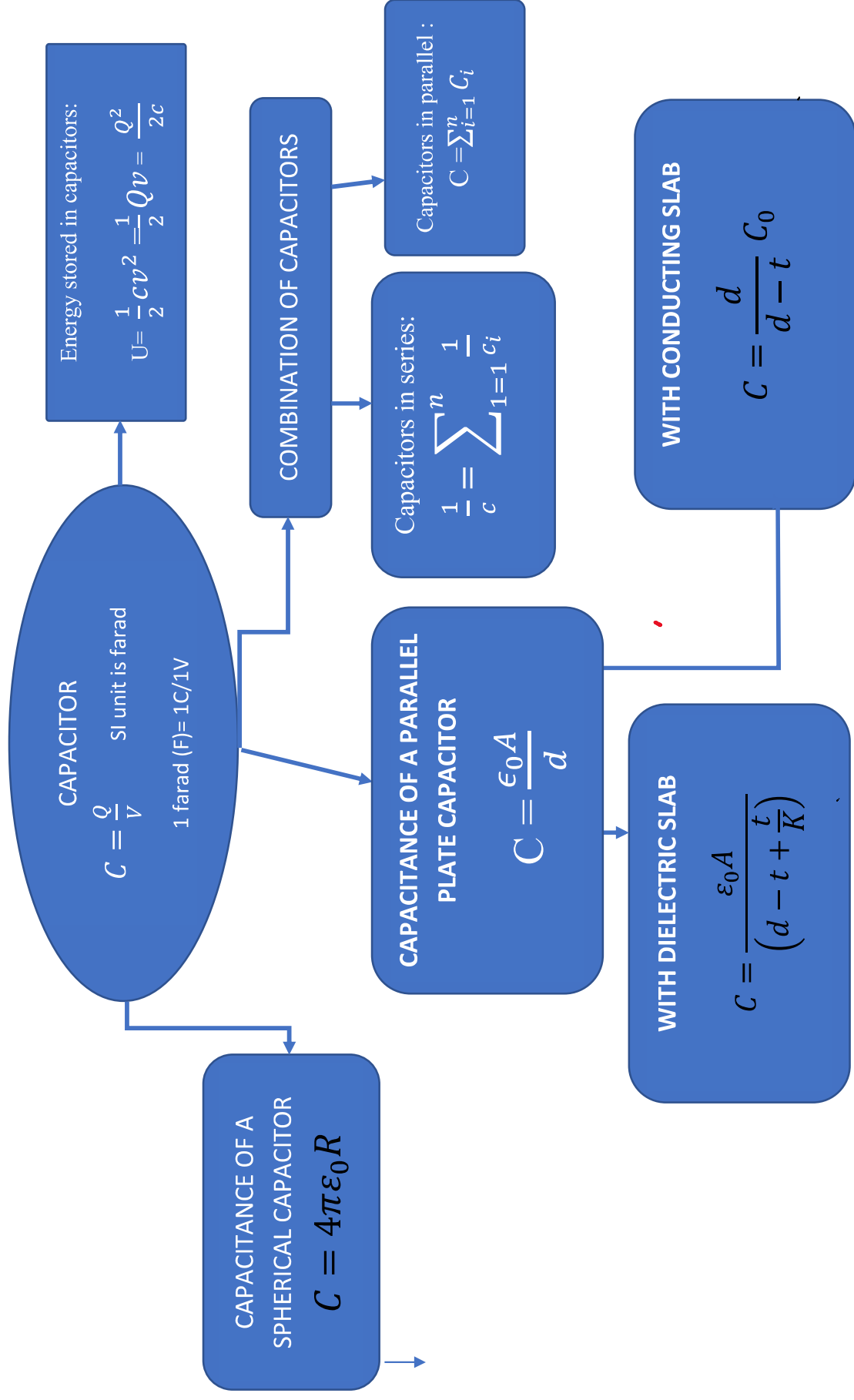
$\Phi_{E \text{ Total}} = q / \epsilon_0$



MIND MAP- ELECTRIC POTENTIAL



MIND MAP- CAPACITORS



CHAPTER-2 ELECTROSTATIC POTENTIAL AND CAPACITANCES

MASTER CARD- ELECTROSTATIC POTENTIAL

Electric potential:- The amount of work done per unit positive test charge in moving the test charge from infinity to that point.

It is scalar quantity.

SI Unit :- volt (V)

Electric potential difference:- If W is work done in moving a small positive test charge q , from point A to B in the electrostatic field of charge Q , then potential difference between points B and A,

$$V_A - V_B = \frac{W_{AB}}{q} = \frac{1}{4\pi\epsilon_0} \frac{Q}{r}$$

Electric potential due to group of charges.

$$V = \frac{1}{4\pi\epsilon_0} \left(\frac{q_1}{r_1} + \frac{q_2}{r_2} + \frac{q_3}{r_3} + \dots + \frac{q_n}{r_n} \right)$$

Potential gradient

$$E = \frac{-dV}{dr}$$

Electric potential at a point due to a dipole:

$$V = \frac{1}{4\pi\epsilon_0} \frac{p \cos \theta}{r^2} = \frac{1}{4\pi\epsilon_0} \frac{\vec{p} \cdot \hat{r}}{r^2}$$

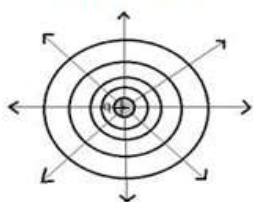
Equipotential Surfaces: A surface with a constant value of potential at all points on the surface.

Example: Surface of a charged conductor

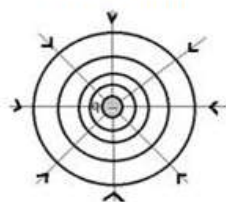
Equipotential Surfaces for various charge systems

For isolated point charge - concentric spheres

(Positive charge)

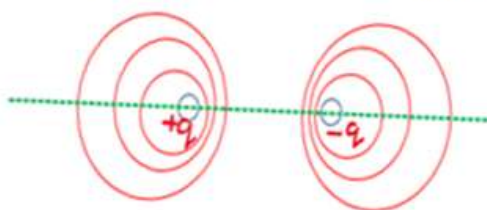


(Negative charge)



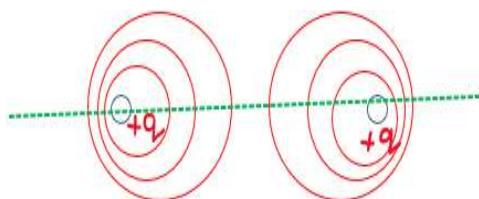
For electric dipole

(system of two equal and opposite charges)

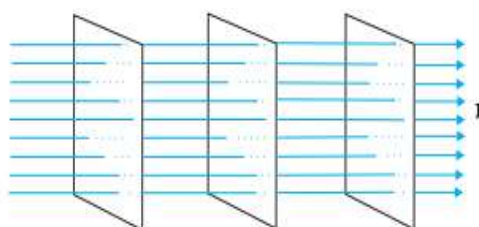


For like charges:

Parallel planes perpendicular to the electric field



For uniform electric field:



Electric Potential Energy

The amount of work done in assembling the charges at their locations by bringing them in, from infinity.

Note that **U** is +ve for like charges and -ve for unlike charges.

For Potential energy of a system of two-point charges:

$$U(r) = \frac{1}{4\pi\epsilon_0} \frac{q_1 q_2}{r_{12}}$$

For Potential energy of a single point charge in external field:

$$U(r) = q V(r)$$

For Potential energy of a system of two-point charges in external field:

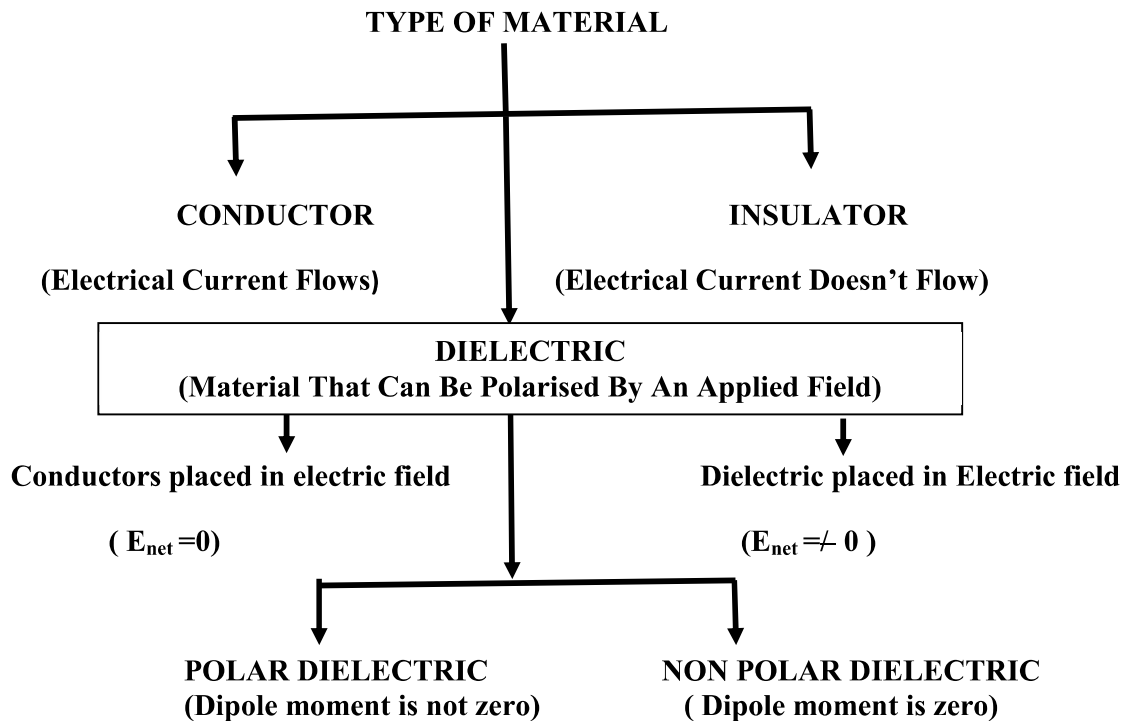
$$U(r) = q_1 V(r_1) + q_2 V(r_2) + \frac{1}{4\pi\epsilon_0} \frac{q_1 q_2}{r_{12}}$$

For Potential energy of a system of three-point charges:

$$U = \frac{1}{4\pi\epsilon_0} \left[\frac{q_1 q_2}{r_{12}} + \frac{q_1 q_3}{r_{13}} + \frac{q_2 q_3}{r_{23}} \right]$$

Potential Energy of dipole in an External Field-

$$U = -p E \cos \theta = -\vec{p} \cdot \vec{E}$$



DIELECTRIC CONSTANT: (K or ϵ_r).

$$K = \epsilon_r = \frac{\epsilon_0}{\epsilon}$$

POLARIZATION DENSITY:.

$$P = \frac{\text{Dipole moment of dielectric}}{\text{volume of dielectric}}$$

$$P = \frac{Qd}{Ad} = \frac{Q}{A} = \sigma_p$$

ELECTRIC SUSCEPTIBILITY: The ratio of the polarization to ϵ_0 times the electric field is called the electric susceptibility of the dielectric.

The unit of electric susceptibility is C^2/Nm^2

DIELECTRIC STRENGTH: The maximum electric field that can exist in a dielectric without causing the breakdown of its insulating property is called dielectric strength of the material.

The Unit of dielectric strength is V/m .

CAPACITOR:-

A device to store charges & electrostatic potential energy.

Capacitance: $C = \frac{Q}{V}$
SI. unit : farad (F)

Capacitance of a parallel plate capacitor with no medium between plates :

$$C_0 = C = \frac{\epsilon_0 A}{d}$$

Capacitance of a parallel plate capacitor with a dielectric medium thickness t

$$C_m = \frac{\epsilon_0 A}{\left(d - t + \frac{t}{K}\right)}$$

Capacitance of a parallel plate capacitor with a dielectric medium thickness t

$$C_m = \frac{\epsilon_0 A}{\left(d - t + \frac{t}{K}\right)}$$

If $t = d$ then $C_m = K \frac{\epsilon_0 A}{d}$
 $\Rightarrow C_m = KC_0$

Combination of capacitors:

(i) Capacitors in series: $\frac{1}{C} = \frac{1}{C_1} + \frac{1}{C_2} + \frac{1}{C_3}$

(ii) Capacitors in parallel : $C = \sum_{i=1}^n C_i$

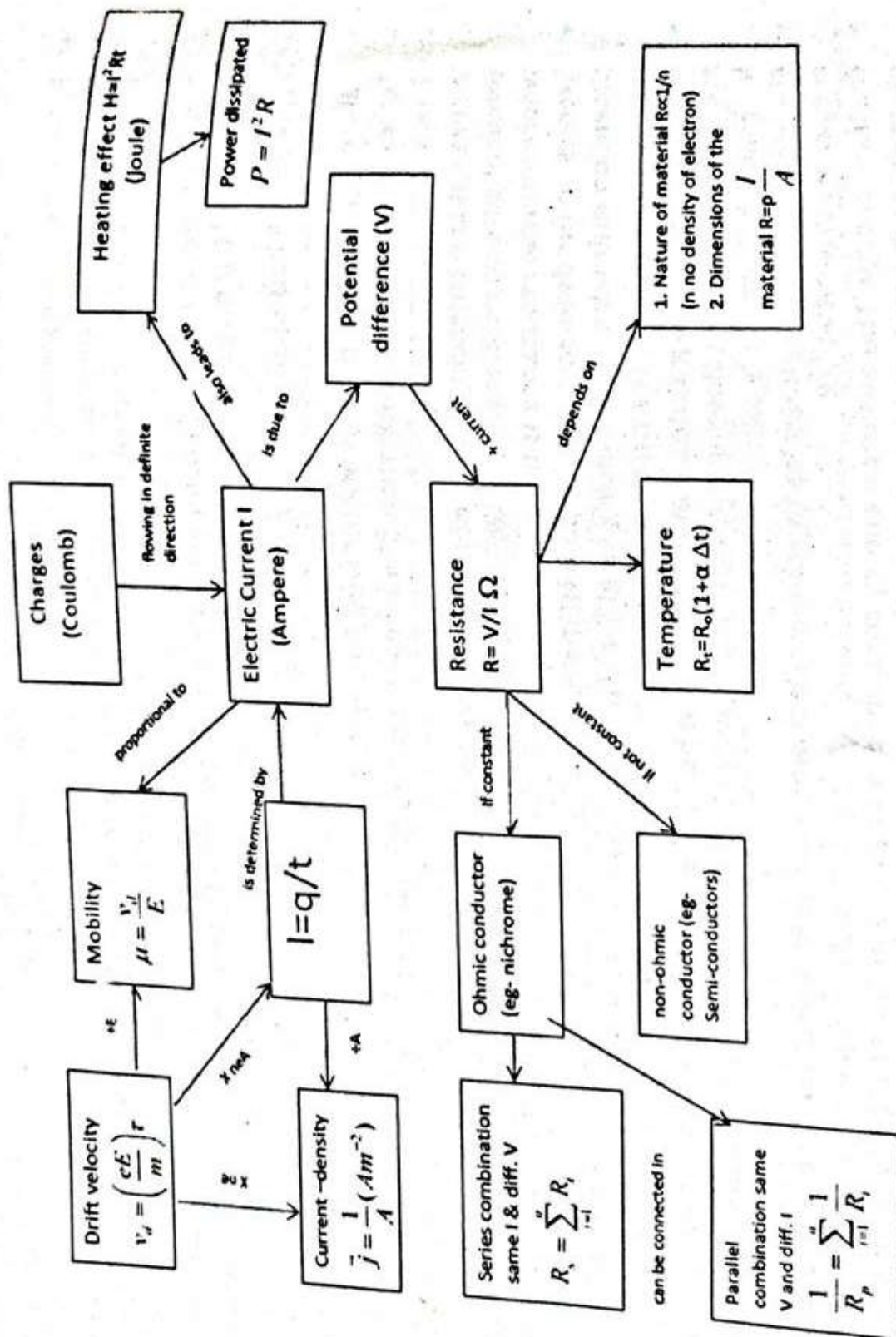
Energy stored in capacitors:

$$U = \frac{1}{2} CV^2 = \frac{1}{2} QV = \frac{Q^2}{2C}$$

***Introducing dielectric slab between the plates of the charged conductor with:**

PROPERTY	BATTERY CONNECTED	BATTERY DISCONNECTED
Charge	KQ_0	Q_0
Potential difference	V_0	V_0/K
Electric Field	E_0	E_0/K
Capacitance	KC_0	KC_0
Energy	$K \frac{1}{2} \epsilon_0 E^2$ (Energy is supplied by battery)	$\frac{1}{K} \frac{1}{2} \epsilon_0 E^2$ (Energy used for polarization)

MIND MAP CHAPTER-3 - CURRENT ELECTRICITY



Master Card -UNIT-2 - CURRENT ELECTRICITY

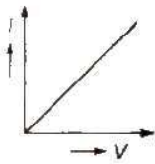
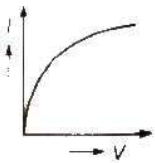
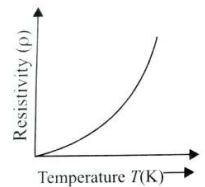
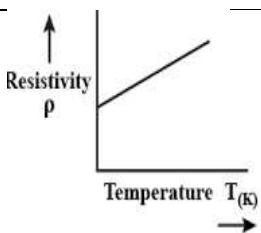
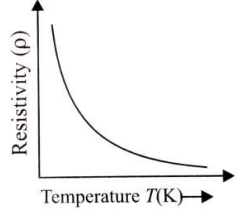
Physical Quantity	FORMULA	MEANING	UNIT
Resistivity of metallic conductor	$\rho_T = \rho_0 [1 + \alpha(T - T_0)]$	ρ_T =Resistivity at T temperature ρ_0 = Resistivity at reference temperature α = temperature co-efficient of resistivity	$\rho : \Omega \text{ m}$ $\alpha : ^\circ\text{C}^{-1}$ $T : ^\circ\text{C}$
temperature co-efficient of resistivity	$\alpha = \frac{R_2 - R_1}{R_1(T_1 - T_2)}$	α = temperature co-efficient of resistivity R_2 = Resistance at final temperature R_1 = Resistance at initial temperature T_1 and T_2 = Initial and final temperature	$\alpha : ^\circ\text{C}^{-1}$ $R_1, R_2: \Omega$ $T_1, T_2 : ^\circ\text{C}$
Electrical Energy	$E = VIt = I^2 R t$	E= Energy, V= Voltage, I= Current, R= Resistance, t= Time	E: joule V: volt I: ampere
Power	$P = VI = I^2 R = \frac{V^2}{R}$	P= Power, V= Voltage, I= Current, R= Resistance	P: watt
Combination of Resistors	1] In Series: $R_{eq} = R_1 + R_2 + \dots + R_n$ 2] In Parallel: $\frac{1}{R_{eq}} = \frac{1}{R_1} + \frac{1}{R_2} + \dots + \frac{1}{R_n}$	R_{eq} = Equivalent resistance	$R_{eq}: \Omega$
EMF of Cell	$\varepsilon = \frac{W}{q}$	ε = emf of cell W= work done q= charge	ε : volt W: joule q: coulomb
Potential Difference of Cell	$V = IR = \varepsilon - Ir$	V= Potential difference, I= Current, R= Resistance, ε = emf, r = Internal resistance	V: volt ε : volt r: Ω
Internal resistance of cell	$r = \frac{\varepsilon}{I} - R$	r= Internal resistance, ε = emf, I= Current, R= External resistance	r, R: Ω
	$I = \frac{\varepsilon}{R + r}$		I: ampere (A)
Combination of Cell	1] In Series: $\varepsilon_{eq} = \varepsilon_1 + \varepsilon_2$ $r_{eq} = r_1 + r_2$	ε_{eq} = Equivalent emf r_{eq} = Equivalent resistance	ε_{eq} : volt $r_{eq} = \Omega$
	$I = \frac{nE}{(R + nr)}$	I= Current, n= no. cells in series, E= emf, R= external resistance, r= internal resistance	I: A E: volt R, r: Ω
	2] In Parallel: $V = \frac{\varepsilon_1 r_2 + \varepsilon_2 r_1}{r_1 + r_2} - I \frac{r_1 r_2}{r_1 + r_2}$	V= Potential Difference, I= Current, $\varepsilon_1, \varepsilon_2$ = emf's of cell 1 and 2 r_1, r_2 = internal resistances of cell 1 and 2	V: volt $\varepsilon_1, \varepsilon_2$: volt $r_1, r_2: \Omega$
	$\varepsilon_{eq} = \frac{\varepsilon_1 r_2 + \varepsilon_2 r_1}{r_1 + r_2}$	ε_{eq} = equivalent emf, $\varepsilon_1, \varepsilon_2$ = emf's of cell 1 and 2 r_1, r_2 = internal resistances of cell 1 and 2	$\varepsilon_{eq} : \text{volt}$ $\varepsilon_1, \varepsilon_2: \text{volt}$ $r_1, r_2: \Omega$
	$r_{eq} = \frac{r_1 r_2}{r_1 + r_2}$	r_{eq} = equivalent resistance r_1, r_2 = internal resistances of cell 1 and 2	$r_{eq}: \Omega$ $r_1, r_2: \Omega$

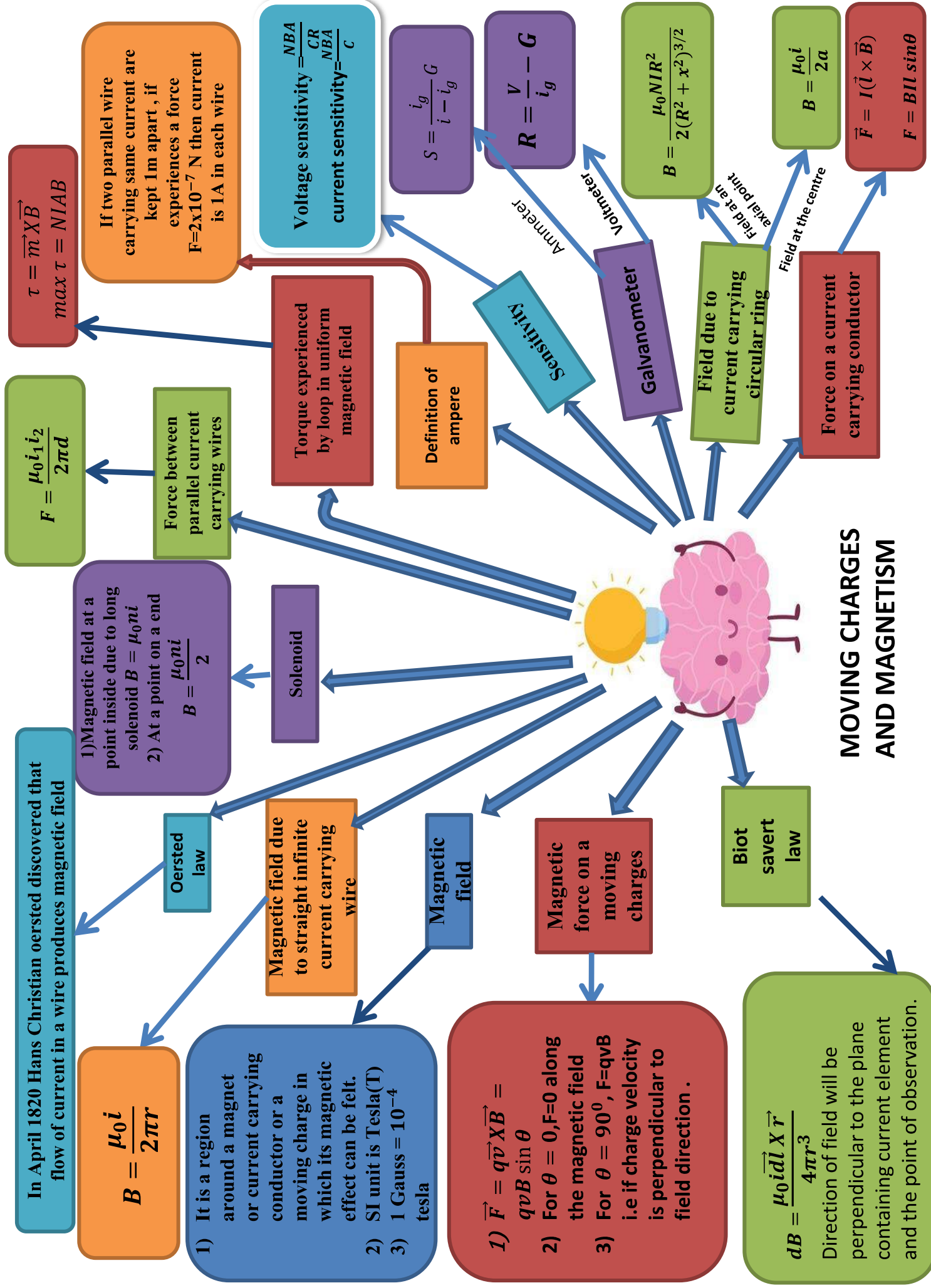
	$\frac{\mathcal{E}_{eq}}{r_{eq}} = \frac{\mathcal{E}_1}{r_1} + \frac{\mathcal{E}_2}{r_2} + \dots + \frac{\mathcal{E}_n}{r_n}$		
	$I = \frac{mE}{(mR + r)}$	I= Current, E= emf, R= external resistance, r= internal resistance, m= number of cells connected in parallel	I: ampere E: emf R, r: Ω
Kirchhoff's Rules:	1] Junction Rule: $\sum I = 0$ 2] Loop Rule: $\sum V = 0$ OR $\sum IR = 0$		
Wheatstone Bridge:	$\frac{R_1}{R_2} = \frac{R_3}{R_4}$	R_1, R_2, R_3, R_4 = Resistances	
Meter Bridge:	$\frac{R}{S} = \frac{l}{(100-l)}$ OR $R = S \frac{l}{(100-l)}$	R= unknown resistance S= known resistance l= Balancing length	R, S: Ω l: cm

Tips:

1] When components are connected in series, then current flowing through them is same.	6] In numerical question diagrams are given, then see the direction of the cell placed in the circuit.
2] When components are connected in parallel, then potential difference across them is same.	7] Alloys have very high resistivity and low temperature coefficient of resistance.
3] If the cells are connected facing each other, then effective emf will be the subtraction of both cells.	8] While calculating total resistance use the internal resistance of cell also.
4] If the storage battery is being charged, so it will not contribute in the total emf of the circuit.	9] In Solving Kirchhoff's rules numerical, use appropriate sign conventions of current and emf of cell or voltage drop.
5] Write the formulas clearly and correctly in numerical questions.	10] In meter bridge numerical, first draw circuit diagram according to given conditions.

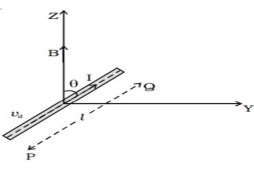
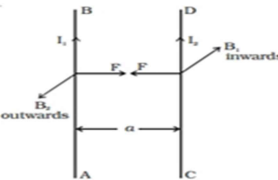
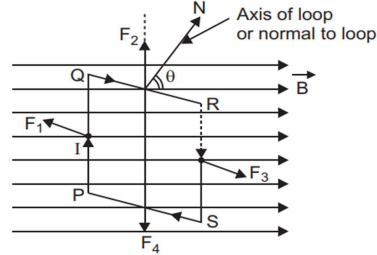
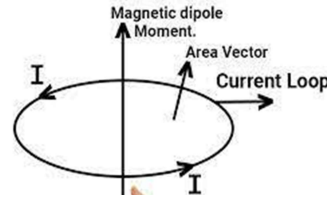
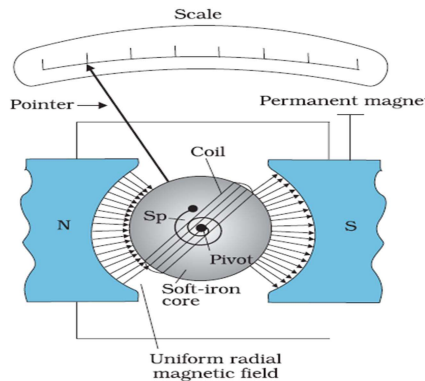
Graphs:

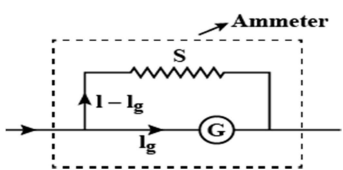
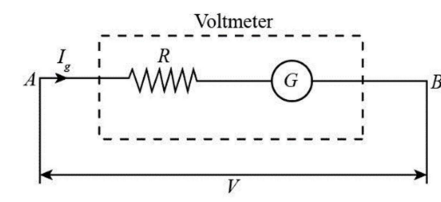
Ohmic Conductors- slope of V-I graph gives Resistance	
Non-Ohmic conductors - V-I graph is not a straight line	
Resistivity ρ_T of copper as a function of temperature T.	
Resistivity ρ_T of nichrome as a function of temperature T.	
Temperature dependence of resistivity for a typical semiconductor.	



CHAPTER - 4 MOVING CHARGE AND MAGNETISM

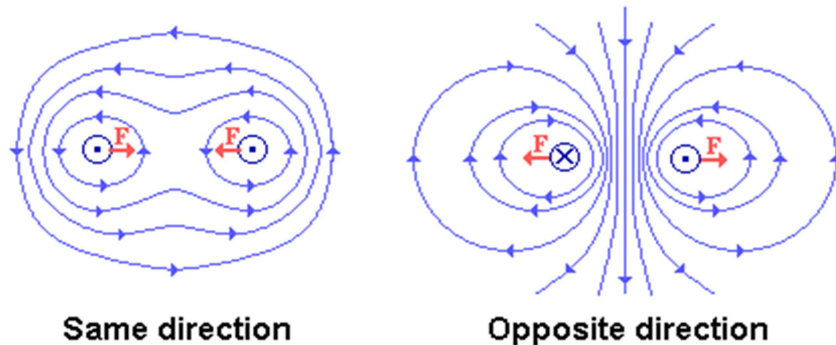
Sr. No.	Term	Formula	Diagram
1	Biot Savart's Law	$dB = \frac{\mu_0 I dl \sin \theta}{4\pi r^2}$	
2	Magnetic field at a point on the axis of a current carrying circular coil	$B = \frac{\mu_0 N I R^2}{2(R^2 + x^2)^{3/2}}$	
3	Magnetic field at a center of a current carrying circular coil	$B = \frac{\mu_0 I}{2r}$	
4	Magnetic field due to a current in a straight conductor	$B_0 = \frac{\mu_0 I}{4\pi r} (\sin \phi_1 + \sin \phi_2)$	
5	Ampere's circuital law	$\oint \vec{B} \cdot d\vec{l} = \mu_0 I$	
6	Magnetic field due to an infinitely long current carrying straight wire	$B = \frac{\mu_0 I}{2\pi R}$	
7	Magnetic field due to straight solenoid	$B = \mu_0 n I$, where $n = N/L$ n = number of turns per unit length	

8	Lorentz force Force on a moving charge in uniform magnetic and electric fields	$\vec{F} = q(\vec{E} + \vec{V} \times \vec{B})$	
9	Force on a current-carrying conductor in a uniform magnetic field	$\vec{F} = I(\vec{l} \times \vec{B})$ $F = BIl \sin\theta$	
10	Force between two parallel current-carrying conductors	$F = \frac{\mu_0 I_1 I_2 l}{2\pi a}$	
11	Torque experienced by a current loop in uniform magnetic field	$\tau = NIBA \sin\theta$ $\vec{\tau} = \vec{m} \times \vec{B}$ Where $m = IA$ = magnetic moment	
12	Current loop as a magnetic dipole and its magnetic dipole moment	$B = \frac{\mu_0 2m}{4\pi x^3}$ Where x is the distance along the axis from the center of the loop $m = NIA = NI\pi r^2$	
13	Moving coil galvanometer -	1. $I = G\theta$ Where $G = \frac{k}{NAB}$ = galvanometer constant K = torsional N = number of turns A = area of coil B = magnetic field θ = deflection	

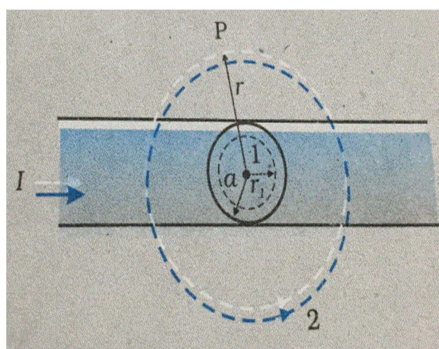
14	Moving coil galvanometer Current sensitivity Voltage sensitivity	$I_s = \frac{\theta}{I} = \frac{NAB}{k}$ $V_s = \frac{\theta}{IR} = \frac{NAB}{kR}$	
15	Conversion of galvanometer to ammeter	$S = \frac{I_g}{I - I_g} G$ G = galvanometer resistance	
16	Conversion of galvanometer to voltmeter	$R = \frac{V}{I_g} - G$ G = galvanometer resistance R = high resistance in series	

GRAPHS :-

1. Field pattern for force between two parallel current carrying conductors -

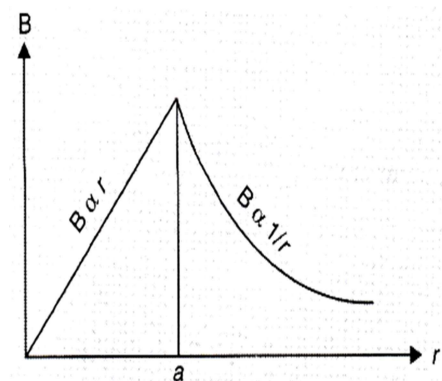


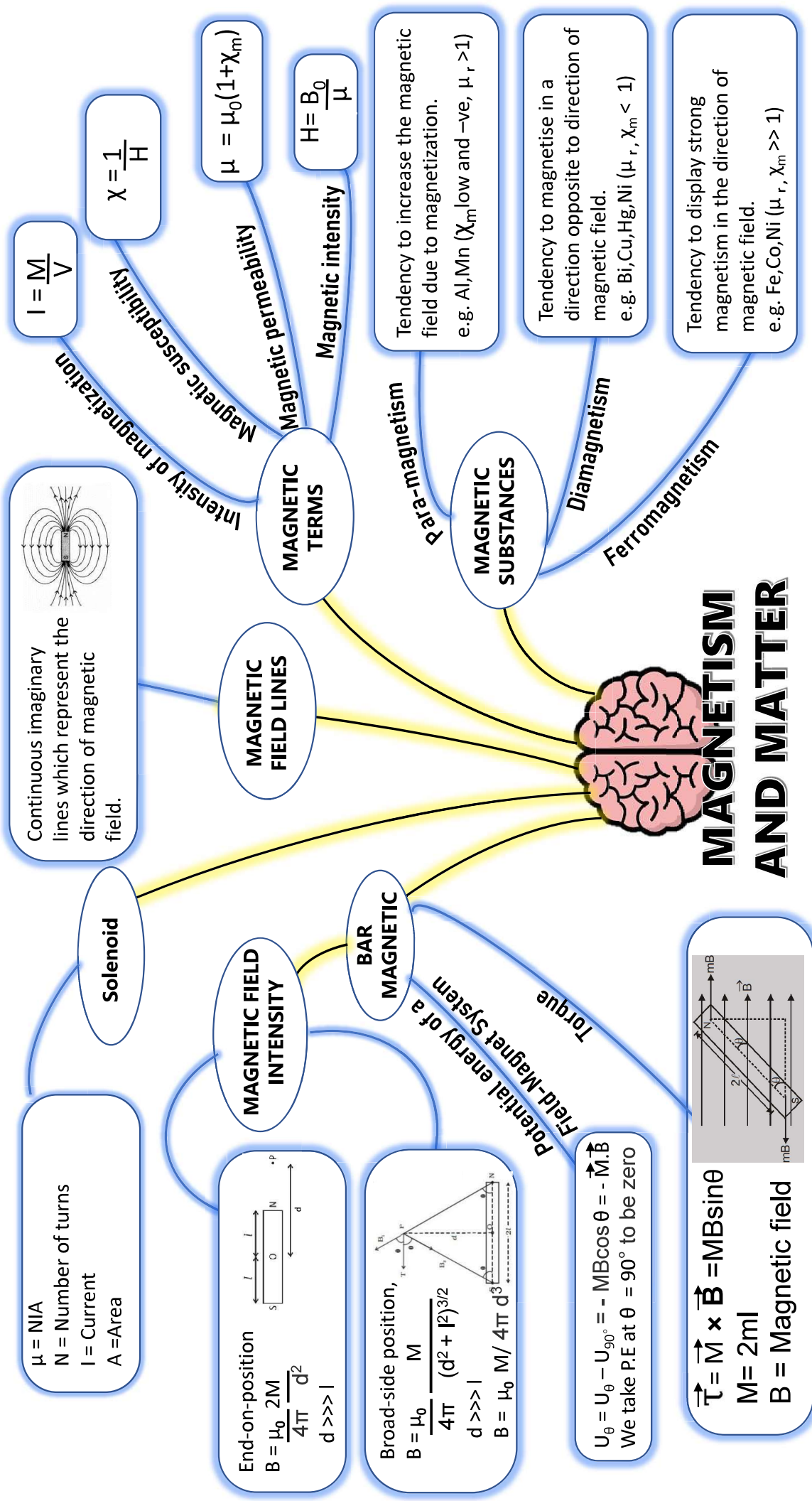
2. Magnetic field in the region $r < a$ and $r > a$, for a long straight wire of a circular cross-section



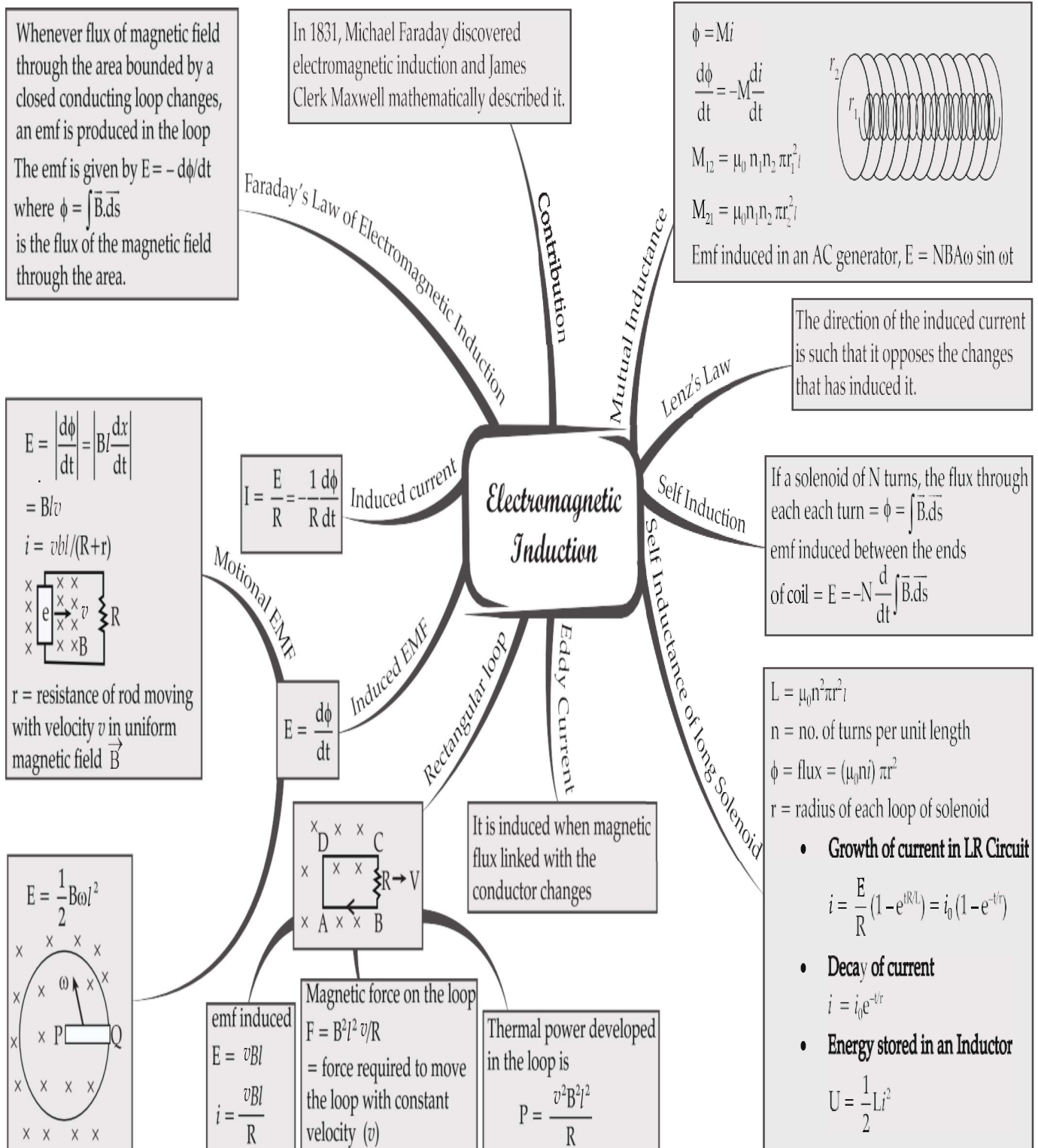
(NCERT image)

A long straight wire of a circular cross-section

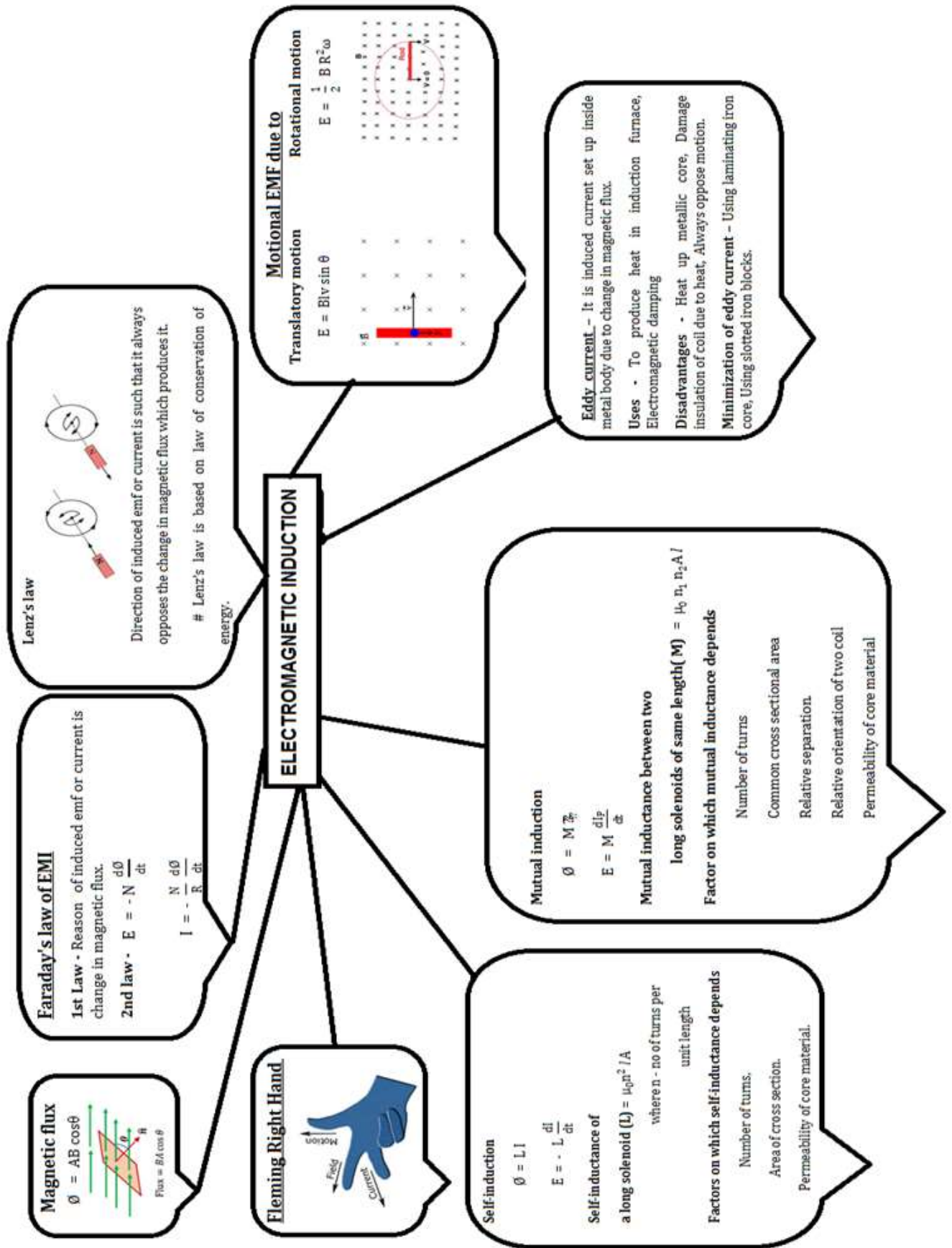




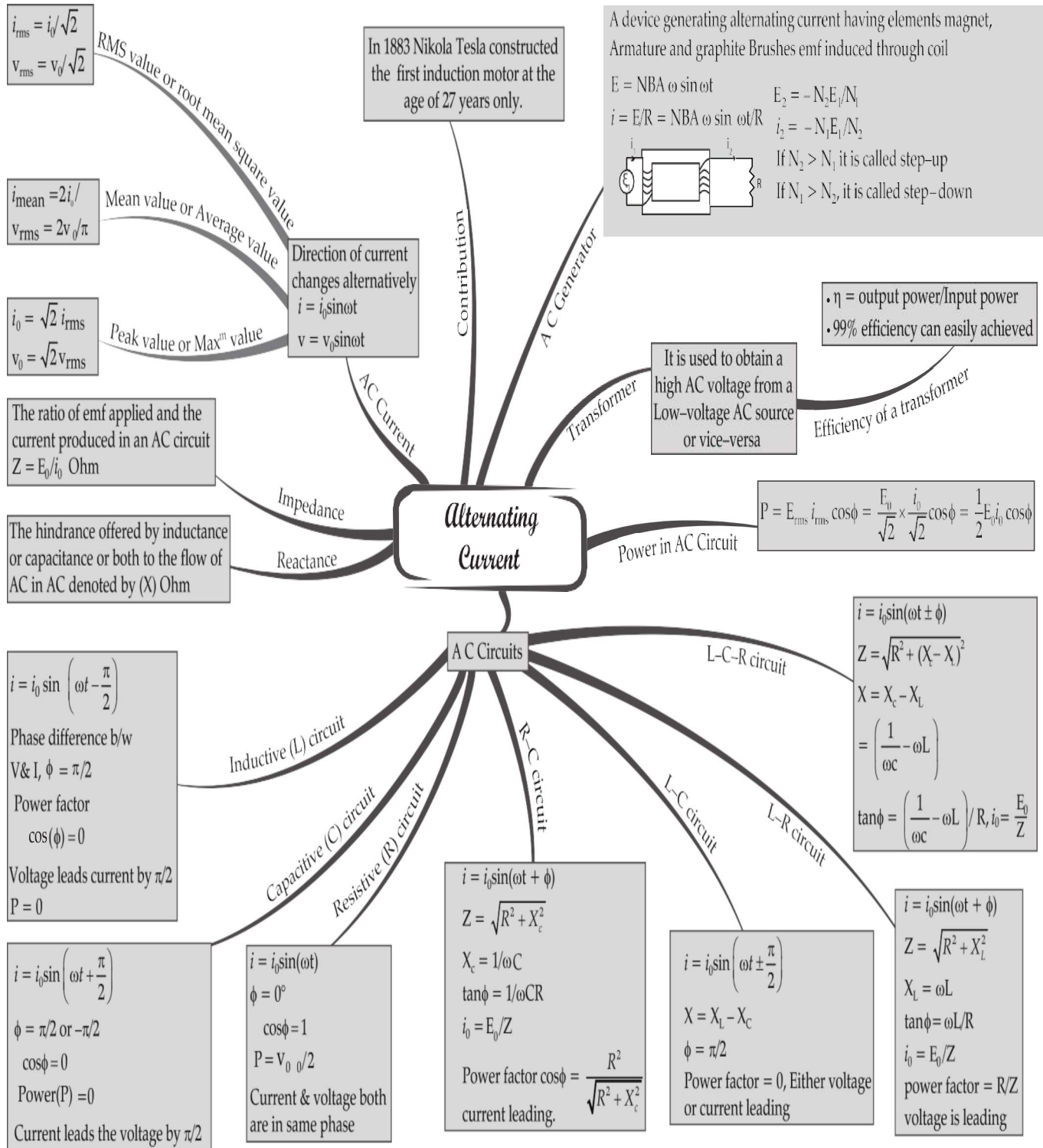
MIND MAP - ELECTRO MAGNETIC INDUCTION



MASTER CARD : CHAPTER 6 ELECTROMAGNETIC INDUCTION

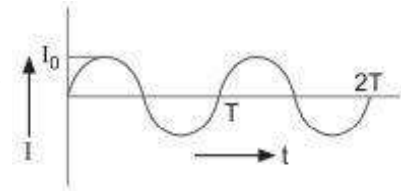


MIND MAP - ALTERNATING CURRENT



MASTER CARD: CHAPTER 7 ALTERNATING CURRENT

1. **AC VOLTAGE AND AC CURRENT:** -The voltage and current whose magnitude changes continuously and direction reverses periodically is called alternating voltage and alternating current.



<u>ALTERNATING CURRENT</u>	<u>ALTERNATING VOLTAGE</u>
$I = I_m \sin(\omega t + \phi)$	$V = V_m \sin \omega t$
$I \rightarrow$ instantaneous value of current $I_m \rightarrow$ Peak value of current $\omega \rightarrow$ angular freq. rad/s $\phi \rightarrow$ phase angle, it gives information about the variation of alternating current with respect to the alternating voltage.	$V \rightarrow$ instantaneous value of voltage $V_m \rightarrow$ Peak value of voltage $\omega \rightarrow$ angular freq. rad/s

2. **Average or mean value of AC over a cycle:** -

Average Alternating current or voltage is zero over a complete cycle.

Hence, Average value is measured over half of a cycle is $I_{av} = \frac{2I_0}{\pi} = 0.636I_0$.

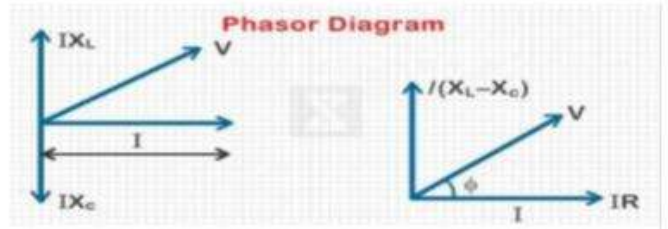
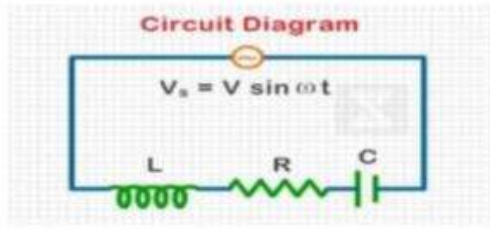
Relation between R.M.S. value and peak value is

$$I_{rms} = \frac{I_m}{\sqrt{2}} = 0.707I_m \quad \text{and} \quad V_{rms} = \frac{V_m}{\sqrt{2}} = 0.707 V_m$$

3. **Phase Difference between Voltage and Current**

If $V = V_m \sin \omega t$ is AC voltage is connected to a circuit having reactive components like **RLC** in series, then the current is $I = I_m \sin(\omega t + \phi)$ where ϕ is the phase difference between the voltage across the source and the current in the circuit.

AC SOURCE CONNECTED WITH	PHASE ϕ	Phase relation with AC source voltage	IMPEDENCE Z	PHASOR DIAGRAM
A pure RESISTOR	0	voltage and current are in phase	$Z=R$	
A pure INDUCTOR	$\frac{\pi}{2}$	voltage leads current by 90°	$Z = X_L = \omega L$	
A pure CAPACITOR	$\frac{\pi}{2}$	Voltage lags current by 90°	$Z = X_C = \frac{1}{\omega C}$	



$$V_m = \sqrt{(I_m R)^2 + (I_m X_C - I_m X_L)^2}$$

$$Z = \frac{V_m}{I_m} = \sqrt{(R)^2 + (X_C - X_L)^2}$$

The effective resistance in series RLC circuit is called the **Impedance Z**.

$$\text{Phase difference between } i \text{ and } V, \quad \tan \phi = \frac{X_L - X_C}{R}$$

4. Impedance and Reactance Impedance:

The effective resistance to alternating current in series RLC circuit is called the **Impedance Z**.

$$Z = \frac{V_m}{I_m} = \sqrt{(R)^2 + (X_C - X_L)^2}$$

Reactance: The opposition offered by inductance and capacitance or both in ac circuit is called reactance.

It is denoted by X_C or X_L .

The opposition due to inductor alone is called the inductive reactance while that due to capacitance alone is called the capacitive reactance.

Inductive reactance, $X_L = \omega L$

Capacitive reactance $X_C = \frac{1}{\omega C}$

If capacitor is charged initially and ac source is removed, then electrostatic energy of

capacitor ($\frac{q^2}{2C}$) is converted into magnetic energy of inductor ($\frac{1}{2} Li^2$) and vice

versa periodically; such oscillations of energy are called LC oscillations. The frequency

is given by $\omega = \frac{1}{\sqrt{LC}}$

- 5. AC Generator:-** It is a device used to convert mechanical energy into electrical energy and is based on the phenomenon of electromagnetic induction. If a coil of N turns, area A is rotated at frequency ν in uniform magnetic field then motional induced EMF in coil (if initially it is perpendicular to field) is $E = E_o \sin \omega t$ with angular frequency $\omega = 2\pi f$ and Peak EMF $E_o = NBA\omega$.

ELECTROMAGNETIC WAVES

Master card

(i) $\oint \mathbf{E} \cdot d\mathbf{S} = q / \epsilon_0$ (Gauss's law in electrostatics)

(ii) $\oint \mathbf{B} \cdot d\mathbf{S} = 0$ (Gauss's law in magnetism)

(iii) $\oint \mathbf{E} \cdot d\mathbf{l} = -d\phi_B / dt$ (Faraday's law of induction)

The current due to flow of charge is often called conduction current,
 $I_c = dq/dt$

The current which arises due to time rate of change of electric flux
(ϕ_E) in some part of the electric circuit.

$$I_d = \epsilon_0 d\phi_E / dt$$

Maxwell's Equations

Conduction Current

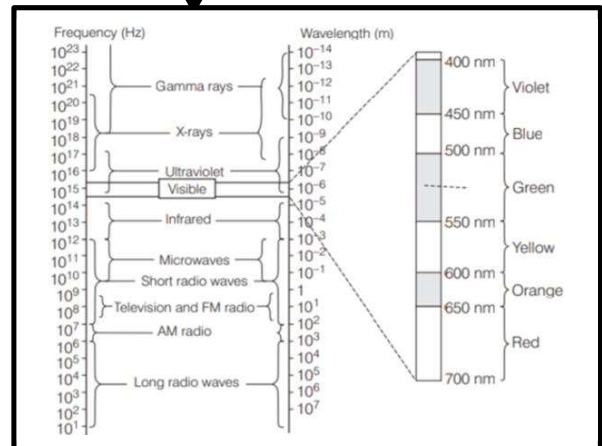
Displacement current

Electromagnetic Waves

Characteristics of EM waves

Electromagnetic Spectrum

- *Combination of mutually perpendicular Electric and magnetic fields is referred as an EM wave.
- *Do not need any material for propagation.
- *Travel with speed of light ($c = 1/\sqrt{\mu_0 \epsilon_0} = 3 \times 10^8 \text{ m/s}$)
- *Produced by accelerated charged particle
- *Transverse in nature
- *Oscillation Electric and magnetic field are in phase and ratio is equal to constant.

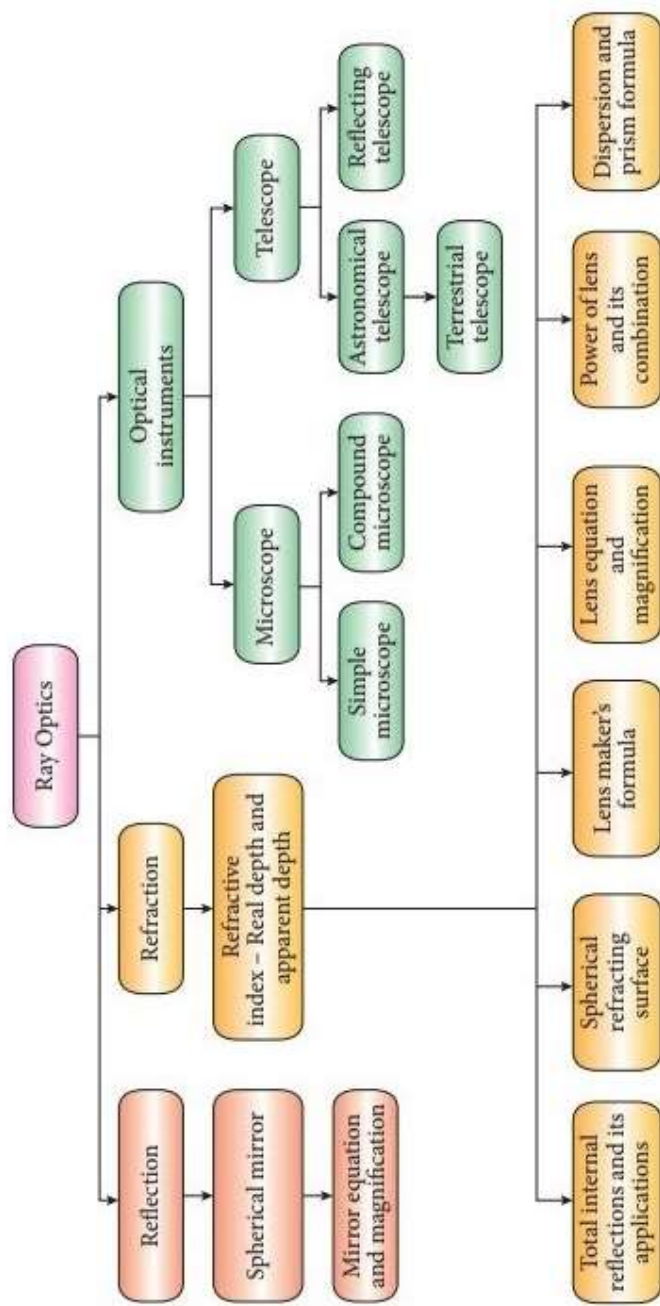


Energy Density

$$U_e (\text{Total energy per unit volume}) = \text{Electrostatic energy density } (\epsilon_0 E^2 / 2) + \text{Magnetostatic energy density } (B^2 / 2 \mu_0).$$

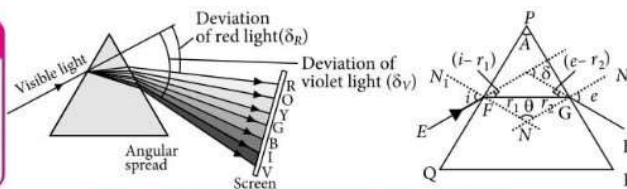
(Electrostatic and magnetic Energy is equally distributed)

CONCEPT MAP



APPLICATIONS OF TIR

- Fiber optics communication
- Medical endoscopy
- Periscope (Using prism)
- Sparkling of diamond



POWER OF LENSES

Power of lens: $P = \frac{1}{f \text{ (in m)}}$

Combination of lenses:

Power: $P = P_1 + P_2 - dP_1P_2$
(d = small separation between the lenses)

For $d = 0$ (lenses in contact)

Power: $P = P_1 + P_2 + P_3 + \dots$

TOTAL INTERNAL REFLECTION

TIR conditions

- Light must travel from denser to rarer.
- Incident angle $i >$ critical angle i_c

Relation between μ and i_c : $\mu = \frac{1}{\sin i_c}$

REFRACTION OF LIGHT

Snell's law: When light travels from medium a

to medium b , $\mu_b = \frac{\mu_a \sin i}{\sin r}$

Refractive index,

$$\mu = \frac{\text{velocity of light in vacuum}}{\text{velocity of light in medium}} = \frac{c}{v}$$

Real and apparent depth
 $\mu = \frac{\text{real depth (x)}}{\text{apparent depth (y)}}$

REFRACTION THROUGH PRISM

Relation between μ and δ_m

$$\mu = \frac{\sin \frac{A + \delta_m}{2}}{\sin \frac{A}{2}} \quad \left\{ \begin{array}{l} \text{where,} \\ \delta_m = \text{angle of minimum deviation} \\ A = \text{angle of prism} \end{array} \right.$$

or $\delta = (\mu - 1)A$ (Prism of small angle)

Angular dispersion

$$= \delta_V - \delta_R = (\mu_V - \mu_R)A$$

Dispersive power,

$$\omega = \frac{\delta_V - \delta_R}{\delta} = \frac{\mu_V - \mu_R}{\mu - 1}$$

Mean deviation, $\delta = \frac{\delta_V + \delta_R}{2}$

THIN SPHERICAL LENS

Thin lens formula: $\frac{1}{v} - \frac{1}{u} = \frac{1}{f}$

Magnification: $m = \frac{v}{u} = \frac{h_i}{h_o}$

REFRACTION BY SPHERICAL SURFACE

Relation between object distance (u), image distance (v) and refractive index (μ)

$$\frac{\mu_{\text{denser}}}{v} - \frac{\mu_{\text{rarer}}}{u} = \frac{\mu_{\text{denser}} - \mu_{\text{rarer}}}{R} \quad (\text{Holds for any curved spherical surface.})$$

Lens maker's formula

$$\frac{1}{f} = (\mu - 1) \left[\frac{1}{R_1} - \frac{1}{R_2} \right]$$

REFLECTION OF LIGHT

According to the laws of reflection,
 $\angle i = \angle r$

If a plane mirror is rotated by an angle θ , the reflected rays rotate by an angle 2θ .

SIMPLE MICROSCOPE

Magnifying power

For final image is formed at D

(least distance) $M = 1 + \frac{D}{f}$

For final image formed at infinity

$$M = \frac{D}{f}$$

REFLECTING TELESCOPE

Magnifying power

$$M = \frac{f_o}{f_e} = \frac{R/2}{f_e}$$

RAY OPTICS

OPTICAL INSTRUMENTS

TELESCOPE

Astronomical telescope

For final image formed at D (least distance)

$$M = \frac{f_o}{f_e} \left(1 + \frac{f_e}{D} \right)$$

In normal adjustment, image formed at infinity
 $M = f_o / f_e$

REFLECTION BY SPHERICAL MIRRORS

Mirror formula, $\frac{1}{u} + \frac{1}{v} = \frac{1}{f} = \frac{2}{R}$

Magnification, $m = -\frac{v}{u} = \frac{h_i}{h_o}$

COMPOUND MICROSCOPE

Magnifying power, $M = m_o \times m_e$

For final image formed at D (least distance)

$$M = \frac{L}{f_o} \left(1 + \frac{D}{f_e} \right)$$

For final image formed at infinity

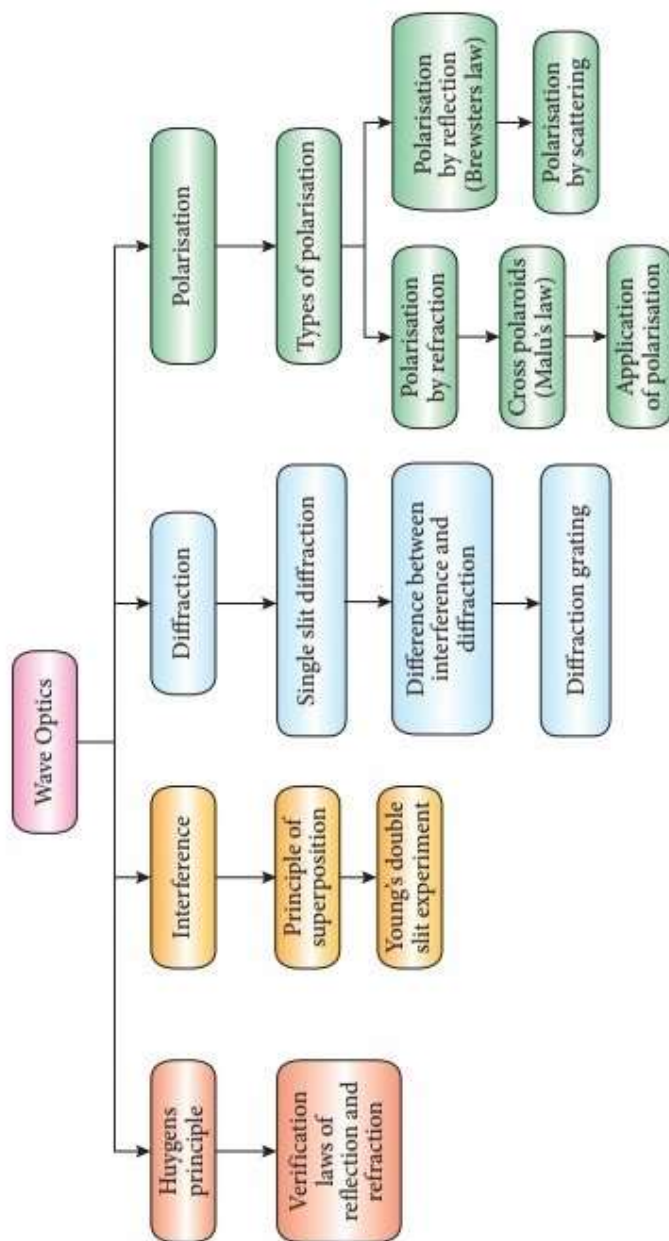
$$M = \frac{L}{f_o} \cdot \frac{D}{f_e}$$

TERRESTRIAL TELESCOPE

For normal adjustment $M = \frac{f_o}{f_e}$

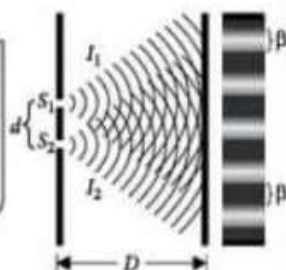
Distance between objective and eyepiece $d = f_o + 4f + f_e$

CONCEPT MAP



REFLECTION AND REFRACTION

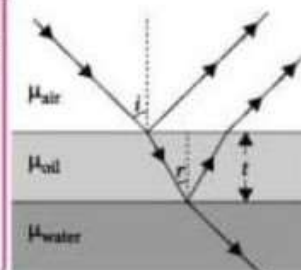
Law of reflection $\angle i = \angle r$
& law of refraction $\frac{\sin i}{\sin r} = \mu$
can be explained by Huygens wave theory.



INTERFERENCE OF LIGHT

The superposition of two coherent waves resulting in a pattern of alternating dark and bright fringes of equal width.

- Position of bright fringes $x_n = \frac{n\lambda D}{d}$
- Position of dark fringes $x'_n = \frac{(2n-1)\lambda D}{2d}$
- Fringe width $\beta = \frac{\lambda D}{d}$
- Ratio of slit width with intensity: $\frac{w_1}{w_2} = \frac{I_1}{I_2} = \frac{a_1^2}{a_2^2}$



ADDITION OF COHERENT WAVE

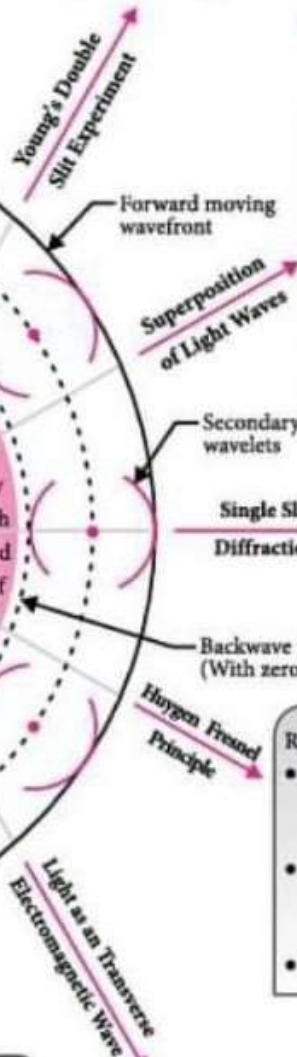
- Resultant intensity
 $I_R = I_1 + I_2 + 2\sqrt{I_1 I_2} \cos \phi$
for bright fringes,
 $I_{\max} = (\sqrt{I_1} + \sqrt{I_2})^2$ at $\phi = 0^\circ, 2\pi, 4\pi, \dots$
for dark fringes,
 $I_{\min} = (\sqrt{I_1} - \sqrt{I_2})^2$ at $\phi = \pi, 3\pi, 5\pi, \dots$
for $I_1 = I_2 = I_0$; $I_R = 4I_0 \cos^2 \frac{\phi}{2}$

INTERFERENCE IN THIN FILM

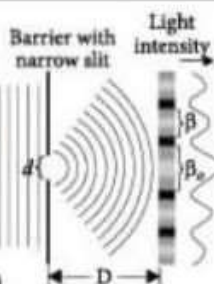
- For reflected Light
Maxima $\rightarrow 2\mu t \cos r = (2n+1)\frac{\lambda}{2}$
Minima $\rightarrow 2\mu t \cos r = n\lambda$
- For transmitted light
Maxima $\rightarrow 2\mu t \cos r = n\lambda$
Minima $\rightarrow 2\mu t \cos r = (2n+1)\frac{\lambda}{2}$
Shift in fringe pattern
 $\Delta x = \frac{\beta}{\lambda} (\mu - 1)t = \frac{D}{d} (\mu - 1)t$
(t = thickness of film, μ = R.I. of the film)

HUYGENS WAVE THEORY

Every point on a wavefront may be considered as a source of secondary spherical wavelets which spread out in the forward direction at the speed of light. The new wavefront is the tangential surface to all of these secondary wavelets at a later time.



Single Slit Diffraction



DIFFRACTION

- Single slit experiment
 - Angular position of n^{th} minima, $\theta_n = \frac{n\lambda}{d}$
 - Angular position of n^{th} maxima, $\theta'_n = \frac{(2n+1)\lambda}{2d}$
 - Width of central maximum $\beta_0 = 2\beta = \frac{2D\lambda}{d}$

FRESNEL'S DISTANCE

- Ray optics as a limiting case of wave optics
- Diffraction at circular aperture
Linear spread, $x = D\theta$ $\left\{ \theta = \frac{1.22 \lambda}{d} \right\}$
Areal spread, $x^2 = (D\theta)^2$
- Fresnel's distance : Distance at which diffraction spread is equal to the size of aperture, $D_F = \frac{d^2}{\lambda}$
- Size of Fresnel zone, $d_F = \sqrt{\lambda D}$

RESOLVING POWER (R.P.)

The ability to resolve the images of two nearby point objects distinctly.

$$\text{R.P.} = \frac{1}{\text{Limit of resolution}}$$

$$\text{R.P. of a microscope} = \frac{1}{d} = \frac{2\mu \sin \theta}{\lambda}$$

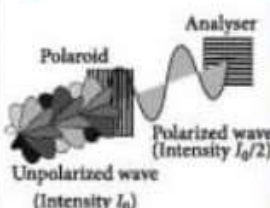
θ = Semi vertical angle subtended at objective.

$$\text{R.P. of a telescope} = \frac{1}{d\theta} = \frac{D}{1.22\lambda}$$

D = Diameter of objective lens of telescope.

DOPPLER'S EFFECT

- Apparent frequency received during relative motion of source and observer
 $v' = v \left(1 - \frac{v}{c} \right)$ (red shift)
 $v' = v \left(1 + \frac{v}{c} \right)$ (blue shift)
Doppler shift: $\Delta v = \pm \frac{v}{c} \times v$
 $\Delta \lambda = \pm \frac{v}{c} \times \lambda \Rightarrow \lambda' - \lambda = \pm \frac{v}{c} \lambda$



POLARISATION OF LIGHT

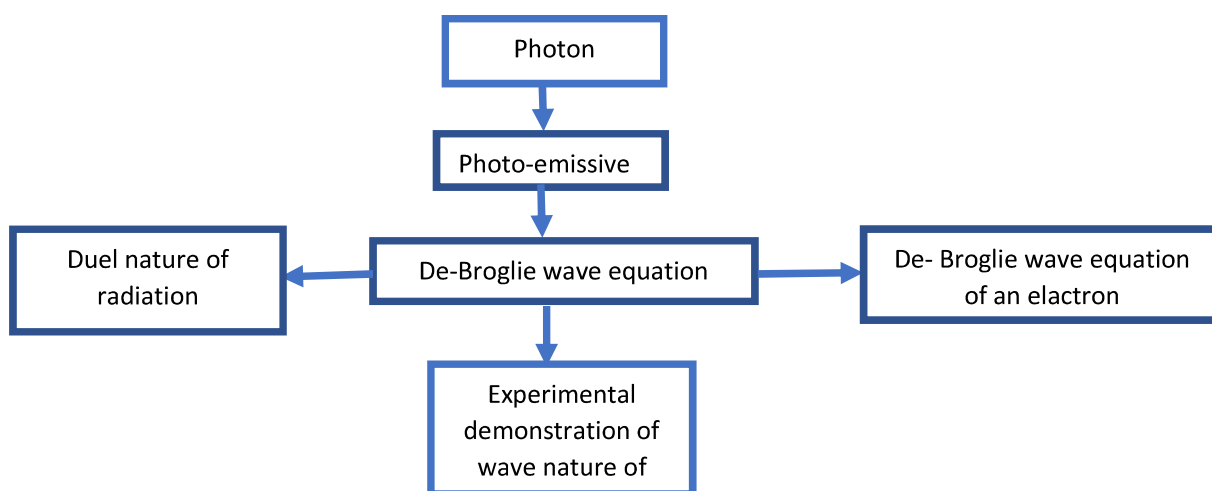
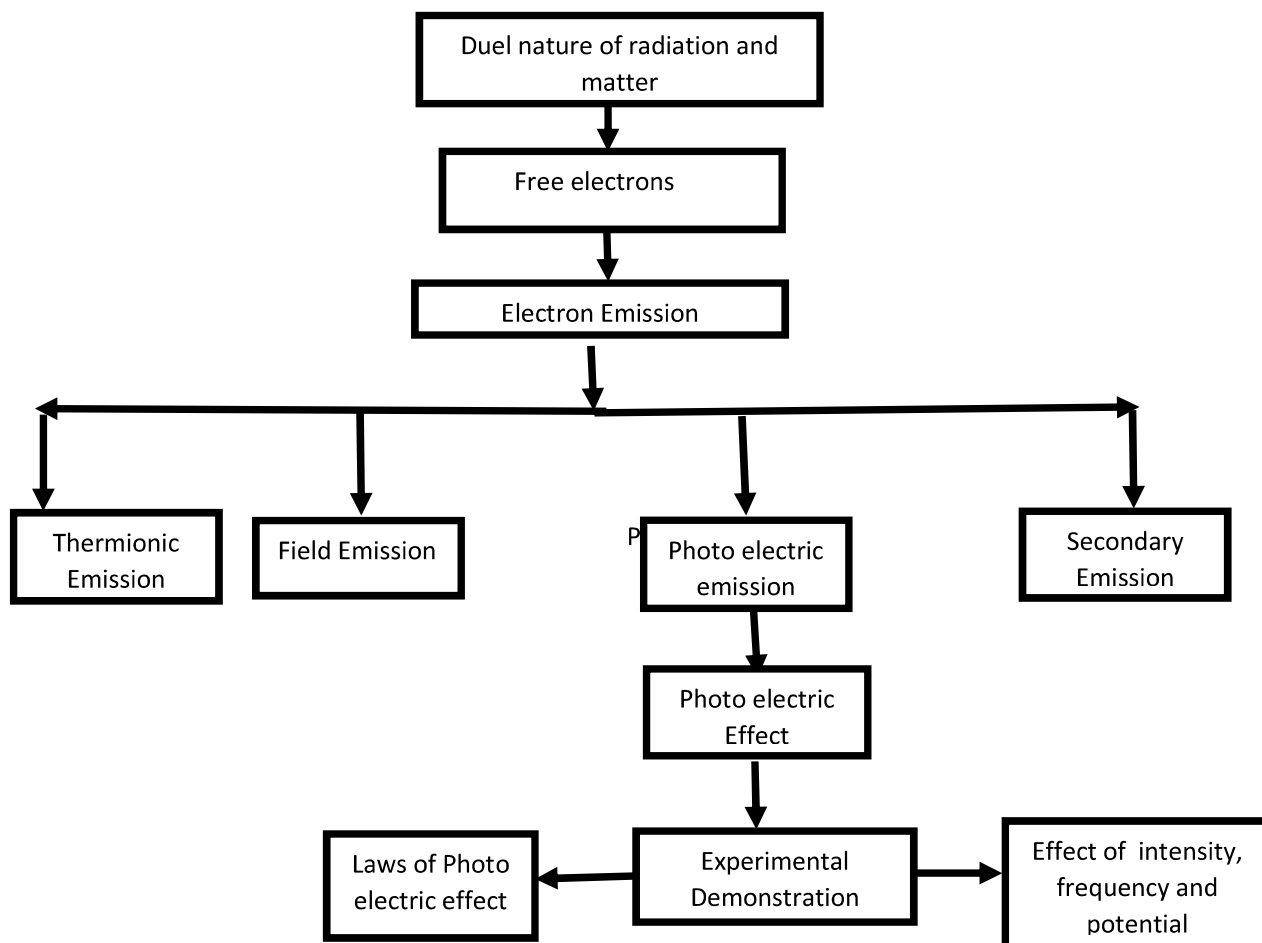
Malus Law: The intensity of transmitted light passed through an analyser is $I = I_0 \cos^2 \theta$
(θ = angle between transmission directions of polariser and analyser)

POLARISATION BY REFLECTION

- Brewster's Law:** The tangent of polarising angle of incidence at which reflected light becomes completely plane polarised is numerically equal to refractive index of the medium
 $\mu = \tan i_p$; i_p = Brewster's angle.
and $i_p + r_p = 90^\circ$

MIND MAP – DUAL NATURE OF RADIATION AND MATTER

Flow Chart



MASTER CARD

CHAPTER 11 DUAL NATURE OF RADIATION AND MATTER

Photon. It is a packet of energy. A photon of frequency ν possesses energy $h\nu$. The rest mass of a photon is zero.

Work function of a metal. The minimum energy, which must be supplied to the electron so that it can just come out of a metal surface, is called the work function of the metal. It is denoted by W

Photoelectric effect. The phenomenon of ejection of electrons from a metal surface, when light of sufficiently high frequency falls on it, is known as photoelectric effect. The electrons so emitted are called photoelectrons.

Threshold frequency. The minimum frequency (ν_0), which the incident light must possess so as to eject photoelectrons from a metal surface, is called threshold frequency of the metal. Mathematically- $W = h\nu_0$

Laws of photoelectric effect. 1. Photoelectric emission takes place from a metal surface, when the frequency of incident light is above its threshold frequency.

2. The photoelectric emission starts as soon as the light is incident on the metal surface.

3. The maximum kinetic energy with which an electron is emitted from a metal surface is independent of the intensity of light and depends upon its frequency.

4. The number of photoelectrons emitted is independent of the frequency of the incident light and depends only upon its intensity.

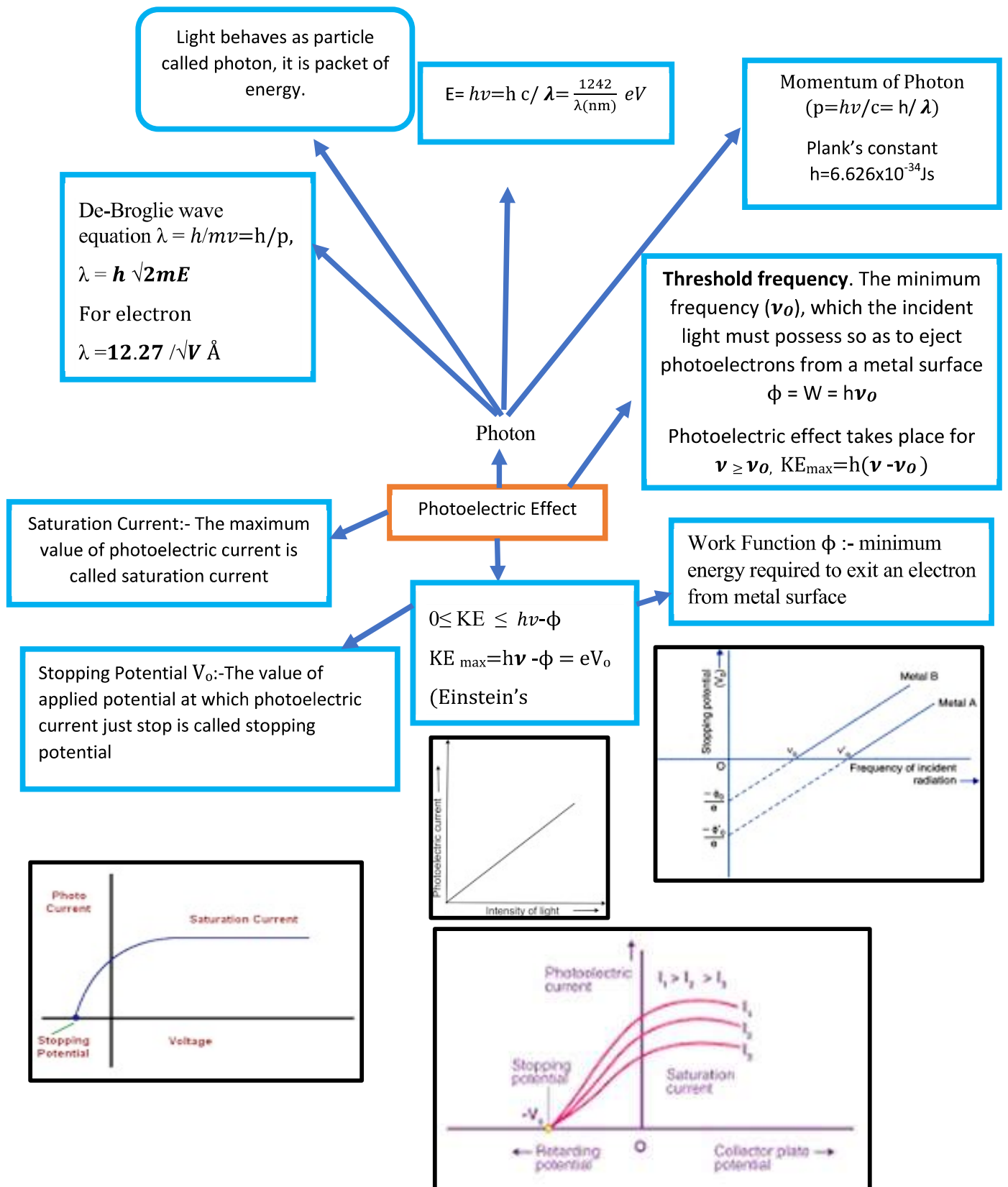
Cut off potential. It is that minimum value of the negative potential (V_0), which should be applied to the anode in a photo cell so that the photoelectric current becomes zero.

Mathematically- $eV_0 = \frac{1}{2} m v_{max}^2$ where v_{max} is the maximum velocity with which the photoelectrons are emitted Einstein's photoelectric equation. When light of frequency ν is incident on a metal surface, whose work function is W (i.e. $h\nu_0$), then the maximum kinetic energy ($\frac{1}{2} m v_{max}^2$) of the emitted photoelectrons is given by $h\nu = h\nu_0 + \frac{1}{2} m v_{max}^2$
 $eV_0 = hc \left(\frac{1}{\lambda} - \frac{1}{\lambda_0} \right)$ It is called Einstein's photoelectric equation. It can explain the laws of photoelectric emission.

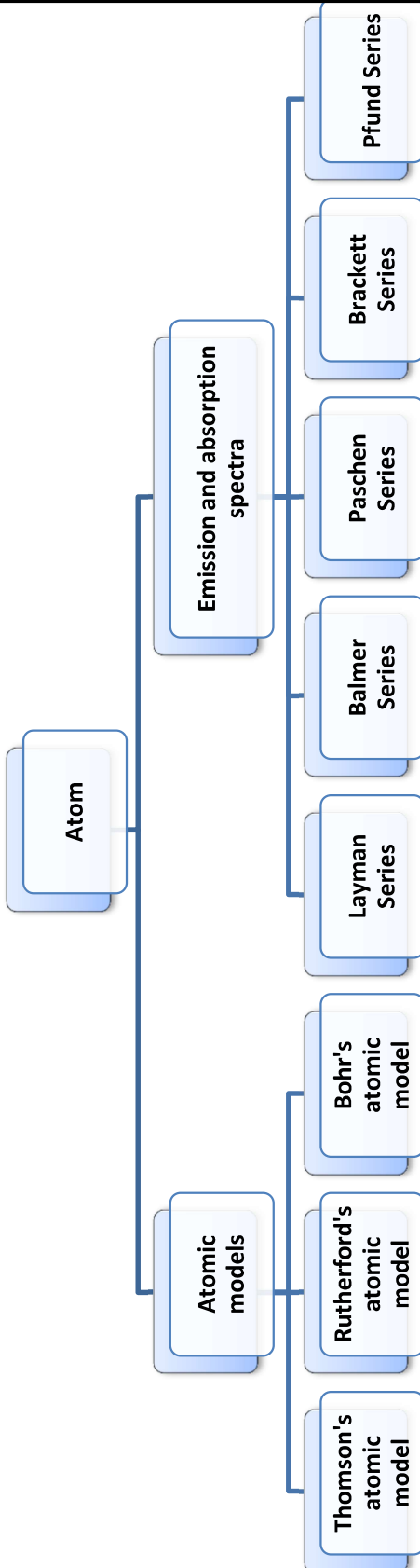
Photoelectric cell. A photocell is an arrangement, which produces electric current, when light falls on its cathode. de-Broglie hypothesis. Both radiation and matter have dual nature. A particle of momentum p is associated with de-Broglie wave of wavelength $\lambda = \frac{h}{p} = \frac{h}{mv}$ The above relation is called de-Broglie relation and the wavelength of the wave associated is called de-Broglie wavelength of the particle.

de-Broglie wavelength of electron. An electron of kinetic energy E possesses de-Broglie wavelength, $\lambda = \frac{h}{\sqrt{2mE}}$ If electron is accelerated through a potential difference V , so as to acquire kinetic energy $E (=eV)$, then $\lambda = \frac{h}{\sqrt{2meV}} = 12.27 \sqrt{V} \text{ \AA}$

MASTER CARD



MIND MAP - ATOMS



ATOMS-MASTER CARD

- Radius of orbit $r = \frac{e^2}{4\pi\epsilon_0 m v^2}$
- Kinetic energy of electron in its orbit $K = \frac{e^2}{4\pi\epsilon_0 r}$
- Potential energy of an electron $U = -\frac{e^2}{4\pi\epsilon_0 r}$
- Velocity of electron in its orbit $v = \frac{e}{\sqrt{4\pi\epsilon_0 m r}}$
- Total energy of an electron in an orbit $E = \frac{e^2}{8\pi\epsilon_0 r}$

Relation between speed, total energy of an electron and its radius with respect to orbital number n:

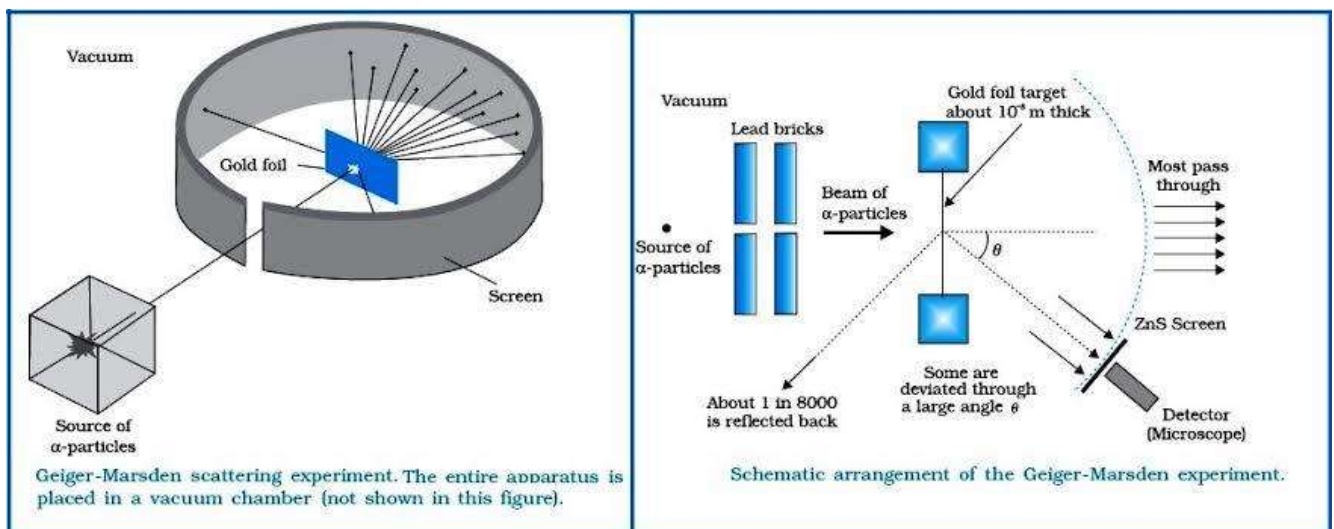
Speed of electron
$$v_n = \frac{1}{n} \frac{e^2}{4\pi\epsilon_0} \frac{1}{h/2\pi}$$

Radius of orbit
$$r_n = \frac{n^2}{m} \frac{h}{2\pi} \frac{4\pi\epsilon_0}{e^2}$$

Bohr Radius ($n = 1$)
$$r_1 = a_0 = \frac{h^2 \epsilon_0}{\pi m e^2} = 0.53 \text{ \AA}$$

Energy for nth orbit electron
$$E_n = \frac{-13.6}{n^2} \text{ eV}$$

Alpha particle scattering Experiment



Source of α -particles -	Radioactive element $^{214}_{83}\text{Bi}$
Target	Very thin Gold foil (Almost transparent)
Properties of Gold	Heavy metal and highest malleability
Screen	ZnS

Experimental Observations:	Conclusions:
Most of the α -particles passed roughly in a straight line	Most of the space in the atom is mostly empty
A very small number of α -particles were deflected	Nucleus has all the positive charges and the mass
Force between α -particles and gold nucleus	$F = \frac{1}{4\pi\epsilon_0} \frac{(2e)(Ze)}{r^2}$

Atomic Spectral Series:

- The atom shows range of spectral lines. Hydrogen is the simplest atom and has the simplest spectrum.
- Balmer Series: Balmer observed the first hydrogen spectral series in visible range of the hydrogen spectrum. It is known as Balmer Series.

The series of spectra for hydrogen were as follows

- Lyman Series : $\frac{1}{\lambda} = R \left[\frac{1}{1^2} - \frac{1}{n^2} \right]$ $n=2,3,4,5\dots$ This is in UV range
- Balmer Series: $\frac{1}{\lambda} = R \left[\frac{1}{2^2} - \frac{1}{n^2} \right]$ where $n=3,4,5\dots$ This is in visible range
- Paschen Series: $\frac{1}{\lambda} = R \left[\frac{1}{3^2} - \frac{1}{n^2} \right]$ $n=4,5,6\dots$ This is in IR range
- Brackett Series: $\frac{1}{\lambda} = R \left[\frac{1}{4^2} - \frac{1}{n^2} \right]$ $n=5,6,7\dots$ This is in IR range
- Pfund Series: $\frac{1}{\lambda} = R \left[\frac{1}{5^2} - \frac{1}{n^2} \right]$ $n=6,7,8\dots$ This is in IR range

R is Rydberg's constant. The value of R is $1.097 \times 10^7 \text{ m}^{-1}$;

Limitations of Rutherford model:

- It could not explain the stability of the atom:.
- It could not explain the nature of energy spectrum:

BOHR'S MODEL AND POSTULATES:

- An electron can revolve in certain stable orbits without emission of radiant energy. These orbits are called stationary states of the atom.
- Electron revolves around nucleus only in those orbits for which the angular momentum is the integral multiple of $\frac{h}{2\pi}$, where, h is Planck's constant. Hence, angular momentum, $L = \frac{nh}{2\pi}$
- When an electron makes a transition from one of its specified non-radiating orbit to another of lower energy. When it does so, a photon of energy $h\nu$ is radiated having energy equal to energy difference between initial and final state.

$$h\nu = E_i - E_f \text{ (where, } \nu \text{ is frequency)}$$

De-Broglie's explanation of Bohr's second postulate by quantization theory:

- In analogy to waves travelling on a string, particle waves can lead to standing waves under resonant conditions. Resonant condition is $l = 2\pi r$ where, l = perimeter of orbit.

For a hydrogen atom, length of the innermost orbit is its perimeter.

Hence $2\pi r = n\lambda$ (i)

According to de-Broglie's wavelength of electron,

$$\lambda = \frac{h}{p}$$

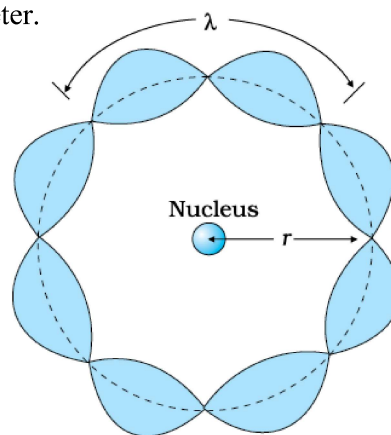
Here $p=mv$, Now equation (i) can be written as

$$2\pi r = n \frac{h}{p} = n \frac{h}{mv} \text{ --- (ii)}$$

Hence, equation (ii) can be reduced as,

$$mvr = n \frac{h}{2\pi} \Rightarrow L = \frac{nh}{2\pi}$$

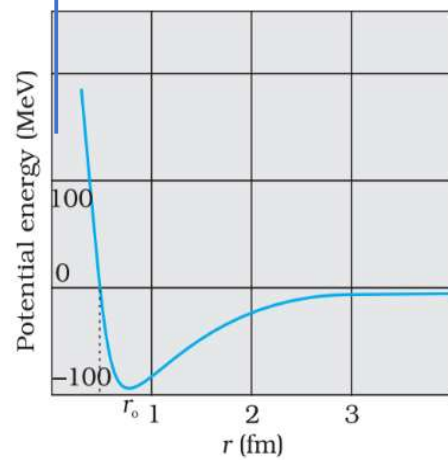
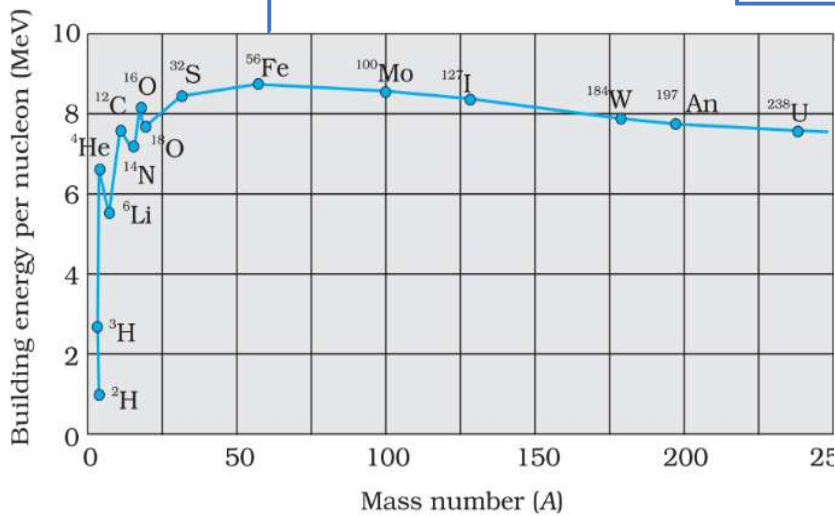
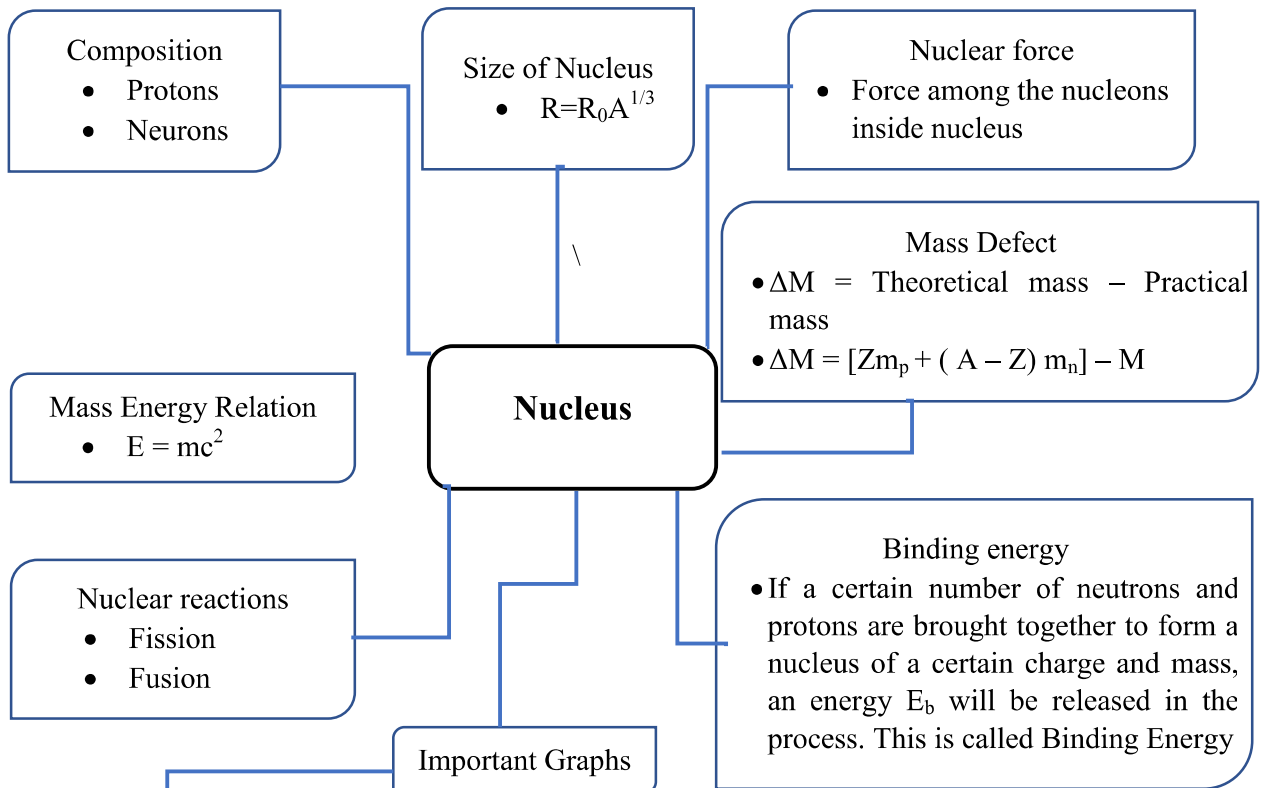
This is Bohr's second postulate.



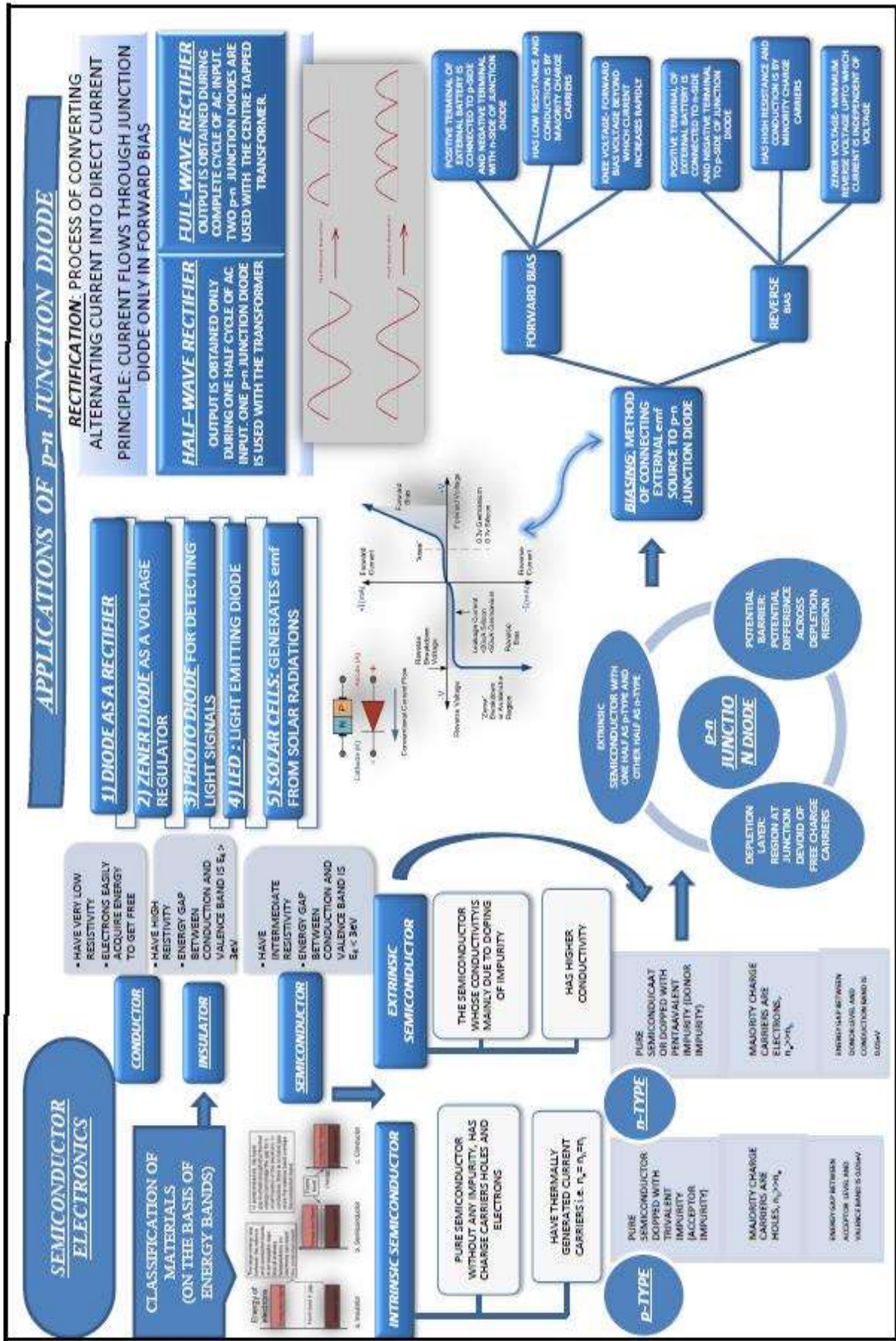
Limitation of Bohr's atomic model:

Bohr's model is for hydrogenic atoms. It does not hold true for a multi-electron model

NUCLEI Master Card



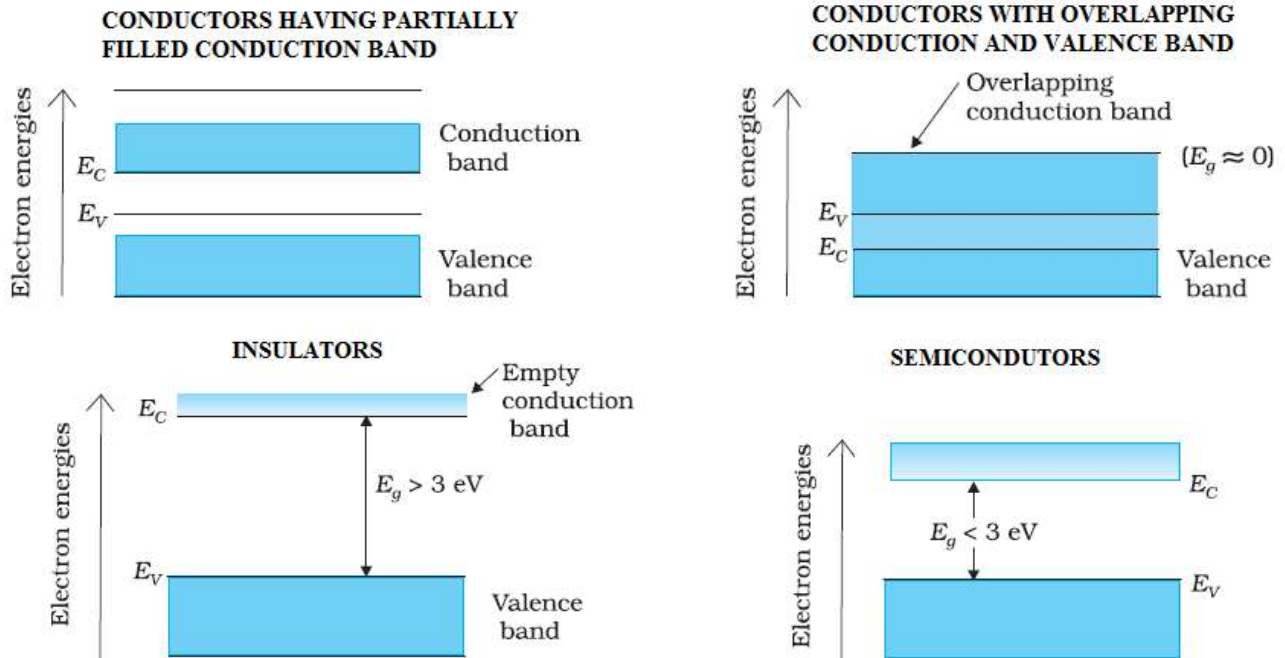
MIND MAP



MASTER CARD

Chapter-14: Semiconductor Electronics: Materials, Devices and Simple Circuits

- **VALANCE BAND** : The energy band containing valance electrons.
- **CONDUCTION BAND** The lowest unfilled energy level just above the valance band
- **FORBIDDEN GAP** Energy gap between valance band and conduction band..



INTRINSIC SEMICONDUCTORS: A pure semiconductor.

Examples: Si: $1s^2, 2s^2, 2p^6, 3s^2, 3p^2$. (Atomic No. is 14) and The energy gap in Si is 1.1 eV

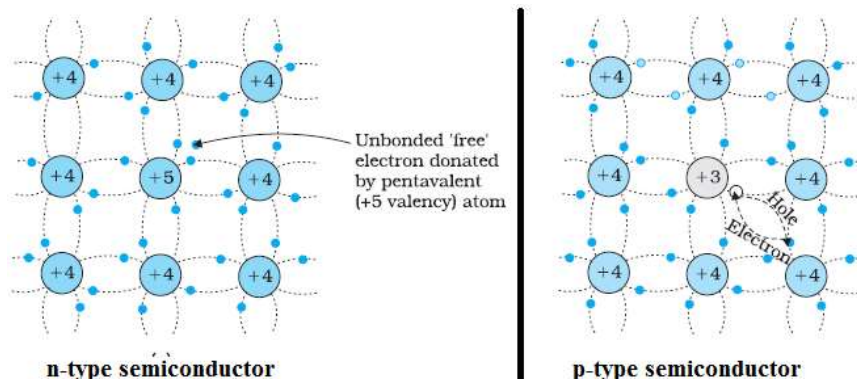
Ge: $1s^2, 2s^2, 2p^6, 3s^2, 3p^6, 3d^{10}, 4s^2, 4p^2$. (Atomic No. is 32) and energy gap in Si is 1.1 eV

MNEMONICS-TO REMEMBER NAMES OF IMPURITIES IN SEMICONDUCTORS

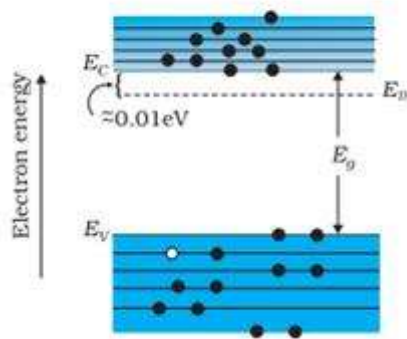
BIG PAA - Boron, Indium, Gallium (all three are trivalent impurities)

Phosphorus, Antimony, Arsenic (all three are pentavalent impurities)

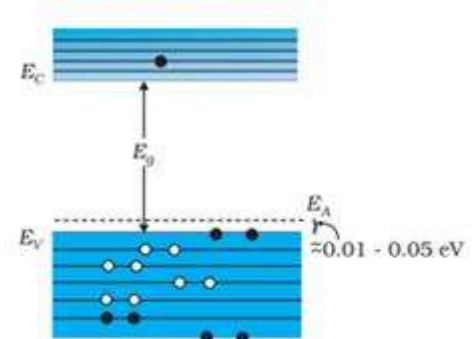
ENERGY BAND DIAGRAMS IN EXTRINSIC SEMICONDUCTORS



1) n-TYPE SEMICONDUCTOR



2) p-TYPE SEMICONDUCTOR



Electrical conductivity of a semiconductor:

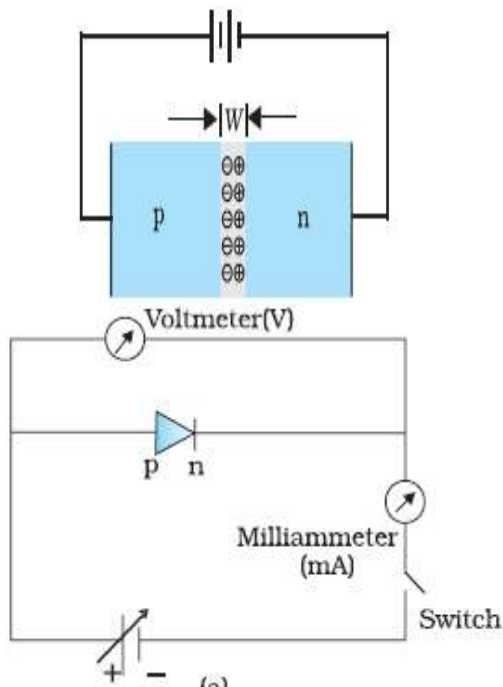
The conductivity of a semiconductor is determined by the mobility (μ) of both electrons and holes and their concentration. Mathematically- $\sigma = e (n_e \mu_e + n_h \mu_h)$.

P-N JUNCTION.

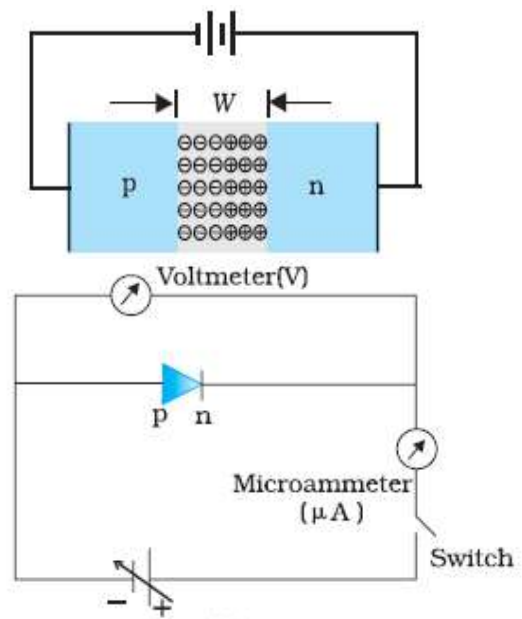
Depletion layer. It is a thin layer formed between the p and n-sections and devoid of holes and electrons. Its width is about 10^{-8} m. A potential difference of about 0.7 V is produced across the junction, which gives rise to a very high electric field ($= 10^6$ V/ m).

Potential Barrier: The difference in potential between p and n regions across the junction makes it difficult for the holes and electrons to move across the junction. This acts as a barrier and hence called 'potential barrier'. **Potential barrier for Si is nearly 0.7 V and for Ge is 0.3 V. The potential barrier opposes the motion of the majority carriers.**

Forward biasing:

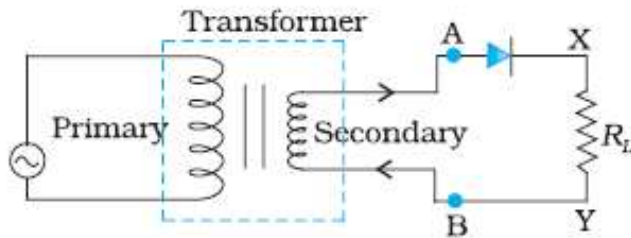


Reverse biasing:

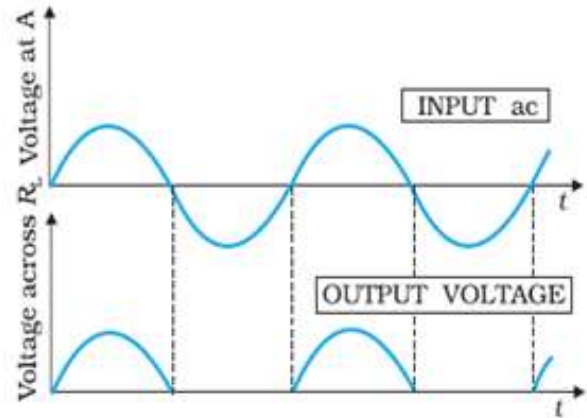


Junction diode as rectifier:

1. **Half wave rectifier:** A rectifier, which rectifies only one half of each a.c. input supply cycle, is called a half wave rectifier. A half wave rectifier gives discontinuous and pulsating d.c. output. As alternative half cycles of the a.c. input supply go waste, its efficiency is very low.

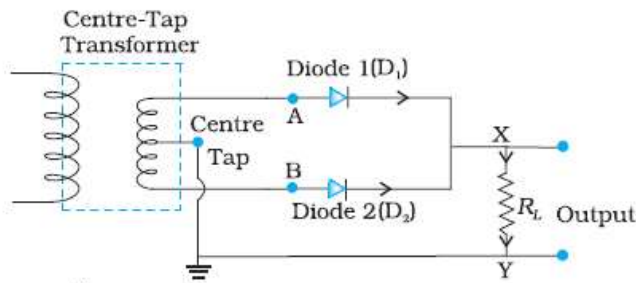


Circuit Diagram

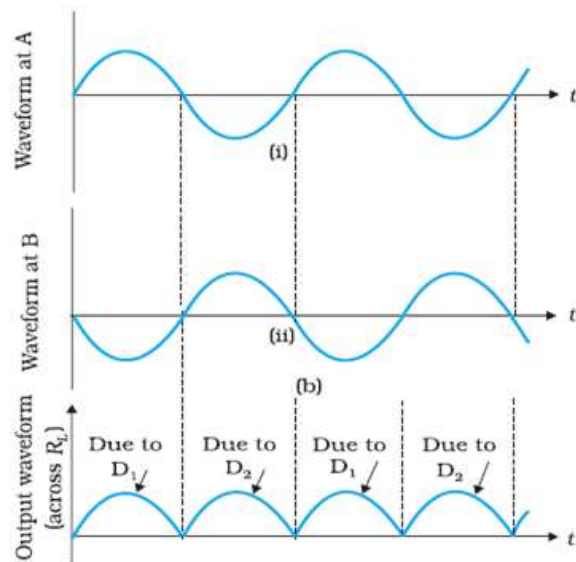


Input- Output Waveform

2. **Full wave rectifier:** A rectifier which rectifies both halves of each a.c. input cycle is called a full wave rectifier. The output of a full wave rectifier is continuous but pulsating in nature. However, it can be made smooth by using a filter circuit.



Circuit Diagram

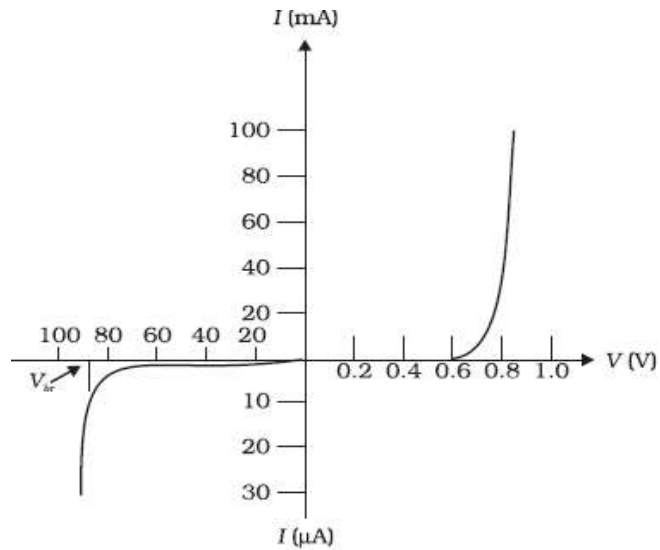


Input- Output Waveform

GRAPHS

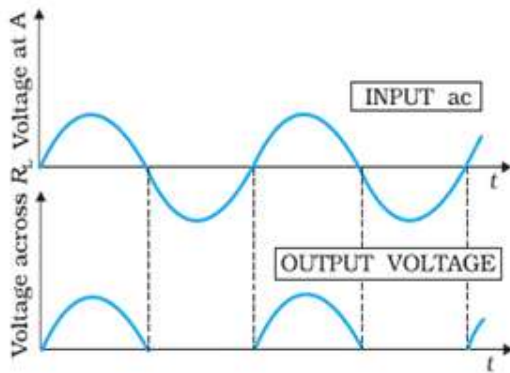
1) I-V CHARACTERISTICS:

Forward Bias & Reverse Bias Characteristics of a P-N Junction Diode

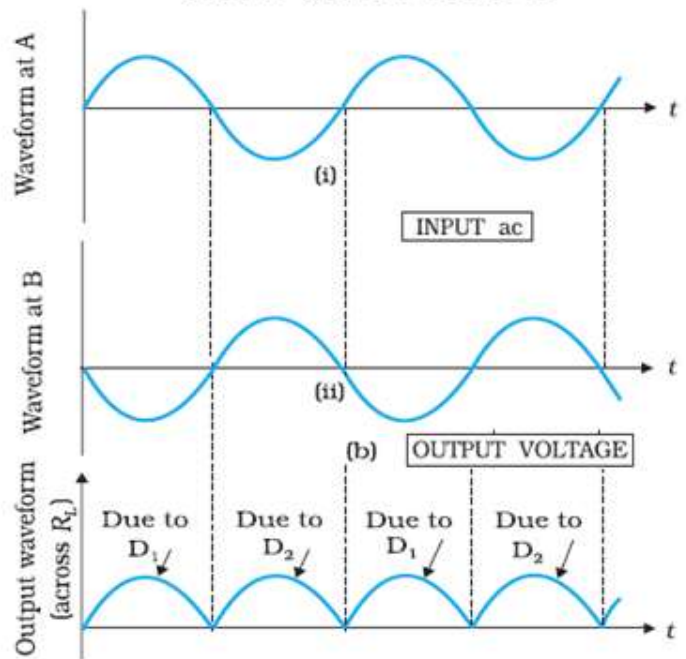


2) INPUT AND OUTPUT VOLTAGE GRAPHS OF

A HALF WAVE RECTIFIER



A FULL WAVE RECTIFIER



TABLES

1) DIFFERENCE BETWEEN INTRINSIC AND EXTRINSIC SEMICONDUCTORS

S.NO	INTRINSIC SEMICONDUCTOR	EXTRINSIC SEMICONDUCTOR
1	Pure form of semiconductor.	Impure form of semiconductor.
2	Conductivity is low	Conductivity is higher than intrinsic semiconductor.
3	The no of holes is equal to no of free electrons	In n-type, the no. of electrons is greater than that of the holes and in p-type, the no. holes is greater than that of the electrons.
4	The conduction depends on temperature.	The conduction depends on the concentration of doped impurity and temperature.

2) DIFFERENCE BETWEEN HALF WAVE AND FULL WAVE RECTIFIER

S.NO	HALF WAVE RECTIFIER	FULL WAVE RECTIFIER
1	Only half cycle of AC is rectified.	Both cycles of AC are rectified.
2	Requires only one diode	Requires two diodes.
3	The output frequency is equal to input supply frequency. (F)	The output frequency is double of the input supply frequency. (2F)
4	The electric current through the load is not continuous	A continuous electric current flow through the load.

FORMULAE

- 1) Electron and hole concentration in a semiconductor in thermal equilibrium

$$n_e n_h = n_i^2$$

- 2) Resistance of a Diode:

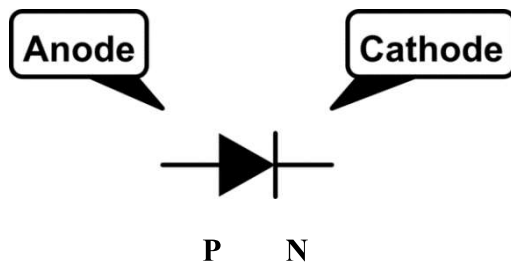
a) Static or DC Resistance $R_{dc} = V/I$

b) Dynamic or AC Resistance

$$R_{a.c} = \Delta V / \Delta I$$

- 1) **TO REMEMBER THE P AND N SECTIONS OF A DIODE.**

The arrow in the schematic symbol for diodes points in the direction of Conventional (positive) current flow.



- 2) Current is **unidirectional** in a diode. **It flows from anode to cathode only.** To remember this, remember the mnemonics '**ACID**' (**ANODE CURRENT IN DIODE**)